

FEATURES

- Optimized for Samsung S5PC100, S5PC110 and S5PV210 Processors
- Three Step-Down DC/DC Converters
- Four Low-Dropout Linear Regulators
- Integrated ActivePath™ Charger
- I²C™ Serial Interface
- Advanced Enable/Disable Sequencing Controller
- Minimal External Components
- Tiny 5×5mm TQFN55-40 Package
 - 0.75mm Package Height
 - Pb-Free and RoHS Compliant

GENERAL DESCRIPTION

The ACT8937 is a complete, cost effective, highly-efficient ActivePMU™ power management solution, optimized for the unique power, voltage-sequencing, and control requirements of the Samsung S5PC100, S5PC110 and S5PV210 processors.

This device features three step-down DC/DC converters and four low-noise, low-dropout linear regulators, along with a complete battery charging solution featuring the advanced ActivePath™ system-power selection function.

The three DC/DC converters utilize a high-efficiency, fixed-frequency (2MHz), current-mode PWM control architecture that requires a minimum number of external components. Two DC/DCs are capable of supplying up to 1100mA of output current, while the third supports up to 1200mA. All four low-dropout linear regulators are high-performance, low-noise, regulators that supply up to 150mA, 150mA, 250mA, and 250mA, respectively.

The ACT8937 is available in a compact, Pb-Free and RoHS-compliant TQFN55-40 package.

TYPICAL APPLICATION DIAGRAM

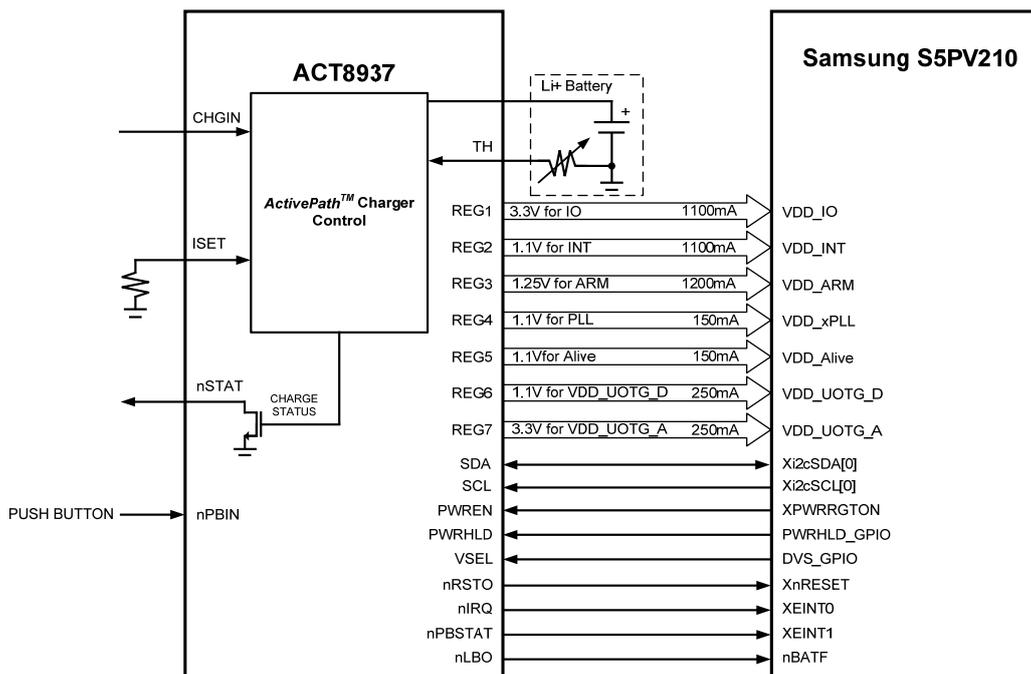
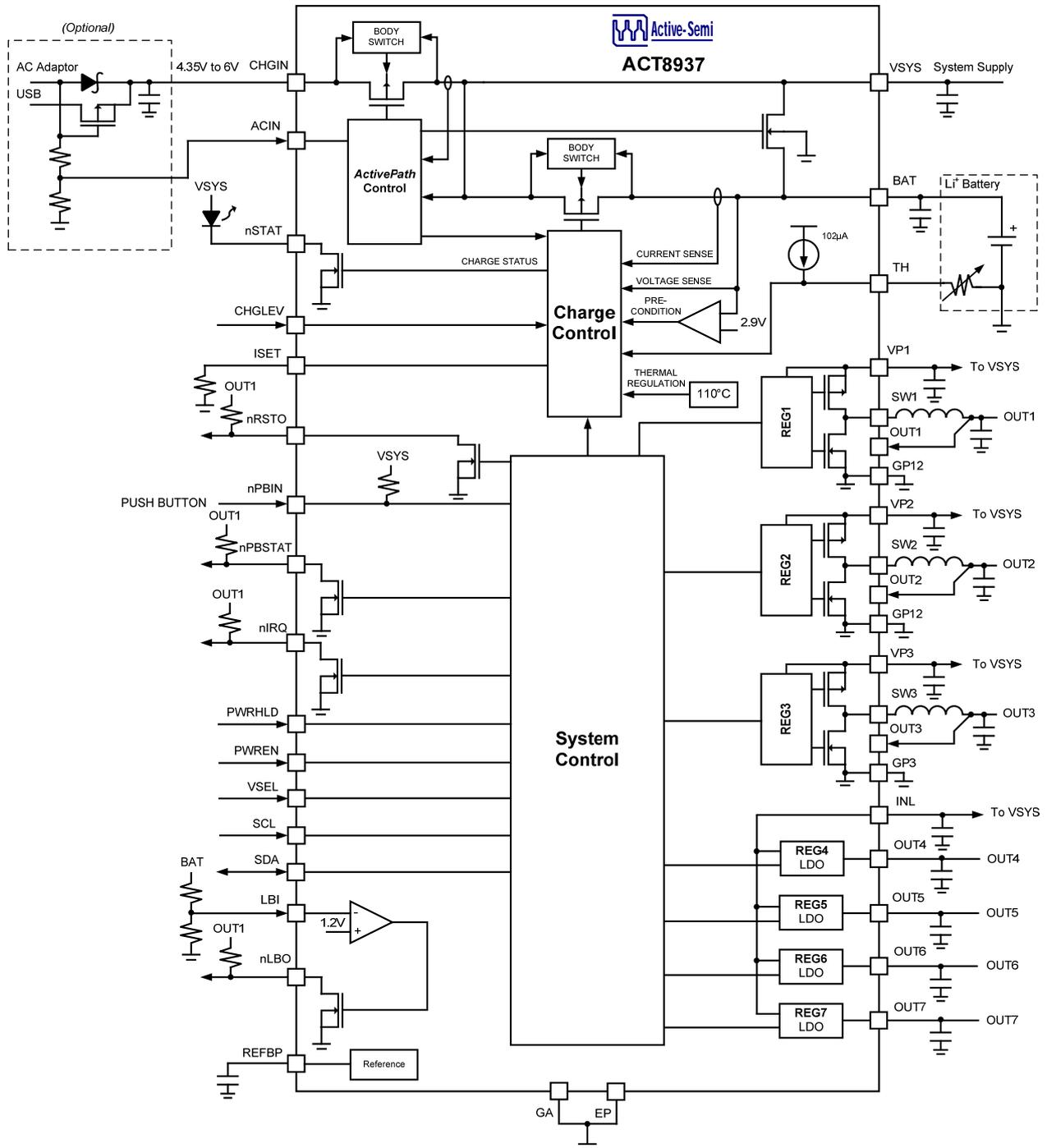


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FUNCTIONAL BLOCK DIAGRAM



ORDERING INFORMATION^{①②}

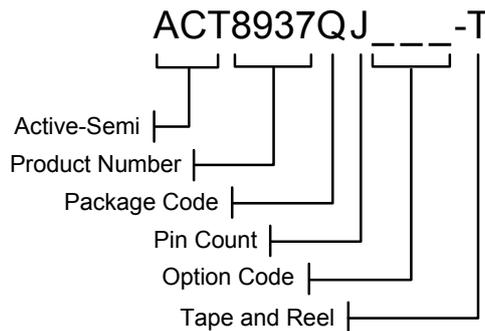
| PART NUMBER ^④ | V _{OUT1} | V _{OUT2} /V _{STBY2} | V _{OUT3} /V _{STBY3} | V _{OUT4} | V _{OUT5} | V _{OUT6} | V _{OUT7} | PROCESSOR |
|--------------------------|-------------------|---------------------------------------|---------------------------------------|-------------------|-------------------|-------------------|-------------------|--------------------|
| ACT8937QJ1or2PQ-T | 3.3V | 1.3V/1.2V | 1.35V/1.2V | 1.2V | 1.2V | 1.2V | 3.3V | S5PC100 |
| ACT8937QJ1or21C-T | 3.3V | 1.1V/1.1V | 1.25V/1.25V | 1.1V | 1.1V | 1.1V | 3.3V | S5PC110 S5PV210 |
| ACT8937QJ1or206-T | 1.8V | 1.1V/1.1V | 1.25V/1.25V | 1.1V | 1.1V | 1.1V | 3.3V | S5PC110 S5PV210 |

①: All Active-Semi components are RoHS Compliant and with Pb-free plating unless specified differently. The term Pb-free means semiconductor products that are in compliance with current RoHS (Restriction of Hazardous Substances) standards.

②: Standard product options are identified in this table. Contact factory for custom options. Minimum order quantity is 12,000 units.

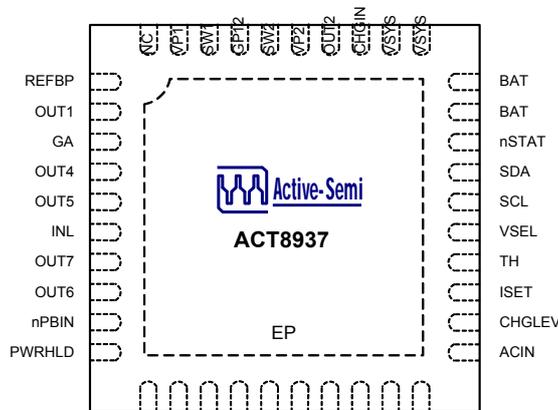
③: To select V_{STBYx} as a output regulation voltage of REGx. Drive VSEL to a logic high. The V_{STBYx} can be set by software via I²C interface, refer to appropriate sections of this datasheet for V_{STBYx} setting.

④: ACT8937QJ1/2PQ-T is optimized for S5PC100, ACT8937QJ1/21C-T and ACT8937QJ1/206-T are optimized for S5PC110 and S5PV210. ACT8937QJ2xx-T, a valid CHGIN Voltage will turn on the PMU.



PIN CONFIGURATION

TOP VIEW



Thin QFN (TQFN55-40)

PIN DESCRIPTIONS

| PIN | NAME | DESCRIPTION |
|-----|---------|---|
| 1 | REFBP | Reference Bypass. Connect a 0.047 μ F ceramic capacitor from REFBP to GA. This pin is discharged to GA in shutdown. |
| 2 | OUT1 | Output Feedback Sense for REG1. Connect this pin directly to the output node to connect the internal feedback network to the output voltage. |
| 3 | GA | Analog Ground. Connect GA directly to a quiet ground node. Connect GA, GP12 and GP3 together at a single point as close to the IC as possible. |
| 4 | OUT4 | Output Voltage for REG4. Capable of delivering up to 150mA of output current. Connect a 1.5 μ F ceramic capacitor from OUT4 to GA. The output is discharged to GA with 1.5k Ω when disabled. |
| 5 | OUT5 | Output Voltage for REG5. Capable of delivering up to 150mA of output current. Connect a 1.5 μ F ceramic capacitor from OUT5 to GA. The output is discharged to GA with 1.5k Ω when disabled. |
| 6 | INL | Power Input for REG4, REG5, REG6, and REG7. Bypass to GA with a high quality ceramic capacitor placed as close as possible to the IC. |
| 7 | OUT7 | Output Voltage for REG7. Capable of delivering up to 250mA of output current. Connect a 2.2 μ F ceramic capacitor from OUT7 to GA. The output is discharged to GA with 1.5k Ω when disabled. |
| 8 | OUT6 | Output Voltage for REG6. Capable of delivering up to 250mA of output current. Connect a 2.2 μ F ceramic capacitor from OUT6 to GA. The output is discharged to GA with 1.5k Ω when disabled. |
| 9 | nPBIN | Master Enable Input. Drive nPBIN to GA through a 50k Ω resistor to enable the IC, drive nPBIN directly to GA to assert a manual reset condition. Refer to the <i>nPBIN Input</i> section for more information. nPBIN is internally pulled up to V _{SY} through a 35k Ω resistor. |
| 10 | PWRHLD | Power Hold Input. Refer to the <i>Control Sequences</i> section for more information. |
| 11 | nRSTO | Active Low Reset Output. See the <i>nRSTO Output</i> section for more information. |
| 12 | nIRQ | Open-Drain Interrupt Output. nIRQ asserts any time an unmasked fault condition exists or a charger interrupt occurs. See the <i>nIRQ Output</i> section for more information. |
| 13 | nPBSTAT | Active-Low Open-Drain Push-Button Status Output. nPBSTAT is asserted low whenever the nPBIN is pushed, and is high-Z otherwise. See the <i>nPBSTAT Output</i> section for more information. |
| 14 | GP3 | Power Ground for REG3. Connect GA, GP12, and GP3 together at a single point as close to the IC as possible. |
| 15 | SW3 | Switching Node Output for REG3. Connect this pin to the switching end of the inductor. |
| 16 | VP3 | Power Input for REG3. Bypass to GP3 with a high quality ceramic capacitor placed as close as possible to the IC. |
| 17 | OUT3 | Output Feedback Sense for REG3. Connect this pin directly to the output node to connect the internal feedback network to the output voltage. |
| 18 | PWREN | Power Enable Input. Refer to the <i>Control Sequences</i> section for more information. |
| 19 | nLBO | Low Battery Indicator Output. nLBO is asserted low whenever the voltage at LBI is lower than 1.2V, and is high-Z otherwise. See the <i>Precision Voltage Detector</i> section for more information. |
| 20 | LBI | Low Battery Input. The input voltage will be compared to 1.2V and output of this comparison drives nLBO. See the <i>Precision Voltage Detector</i> section for more information. |
| 21 | ACIN | AC Input Supply Detection. See the <i>Charge Current Programming</i> section for more information. |
| 22 | CHGLEV | Charge Current Selecting Input. See the <i>Charge Current Programming</i> section for more information. |
| 23 | ISET | Charge Current Set. Program the maximum charge current by connecting a resistor (R _{ISET}) between ISET and GA. See the <i>Charge Current Programming</i> section for more information. |
| 24 | TH | Temperature Sensing Input. Connect to battery thermistor. TH is pulled up with a 102 μ A current internally. See the <i>Battery Temperature Monitoring</i> section for more information. |

PIN DESCRIPTIONS CONT'D

| PIN | NAME | DESCRIPTION |
|--------|-------|---|
| 25 | VSEL | Step-Down DC/DCs Output Voltage Selection. Drive to logic low to select default output voltage. Drive to logic high to select secondary output voltage. See the <i>Output Voltage Programming</i> section for more information. |
| 26 | SCL | Clock Input for I ² C Serial Interface. |
| 27 | SDA | Data Input for I ² C Serial Interface. Data is read on the rising edge of SCL. |
| 28 | nSTAT | Active-Low Open-Drain Charger Status Output. nSTAT has a 8mA (typ) current limit, allowing it to directly drive an indicator LED without additional external components. See the <i>Charge Status Indicator</i> section for more information. |
| 29, 30 | BAT | Battery Charger Output. Connect this pin directly to the battery anode (+ terminal) |
| 31, 32 | VSYS | System Output Pin. Bypass to GA with a 10µF or larger ceramic capacitor. |
| 33 | CHGIN | Power Input for the Battery Charger. Bypass CHGIN to GA with a capacitor placed as close to the IC as possible. The battery charger is automatically enabled when a valid voltage is present on CHGIN . |
| 34 | OUT2 | Output Feedback Sense for REG2. Connect this pin directly to the output node to connect the internal feedback network to the output voltage. |
| 35 | VP2 | Power Input for REG2. Bypass to GP12 with a high quality ceramic capacitor placed as close as possible to the IC. |
| 36 | SW2 | Switching Node Output for REG2. Connect this pin to the switching end of the inductor. |
| 37 | GP12 | Power Ground for REG1 and REG2. Connect GA, GP12 and GP3 together at a single point as close to the IC as possible. |
| 38 | SW1 | Switching Node Output for REG1. Connect this pin to the switching end of the inductor. |
| 39 | VP1 | Power Input for REG1. Bypass to GP12 with a high quality ceramic capacitor placed as close as possible to the IC. |
| 40 | NC | No Connect. Not internally connected. |
| EP | EP | Exposed Pad. Must be soldered to ground on PCB. |

ABSOLUTE MAXIMUM RATINGS^①

| PARAMETER | VALUE | UNIT |
|--|----------------------------------|--------|
| VP1, VP2 to GP12 VP3 to GP3 | -0.3 to +6 | V |
| BAT, VSYS, INL to GA | -0.3 to +6 | V |
| CHGIN to GA t < 1ms and duty cycle <1% Steady State | -0.3 to +18 -0.3 to +14 | V V |
| SW1, OUT1 to GP12 | -0.3 to (V _{VP1} + 0.3) | V |
| SW2, OUT2 to GP12 | -0.3 to (V _{VP2} + 0.3) | V |
| SW3, OUT3 to GP3 | -0.3 to (V _{VP3} + 0.3) | V |
| nPBIN, ACIN, CHGLEV, ISET, TH, nSTAT, SCL, SDA, REFBP, PWRHLD, PWREN, VSEL, nLBO, LBI, nPBSTAT, nIRQ, nRSTO to GA | -0.3 to +6 | V |
| OUT4, OUT5, OUT6, OUT7 to GA | -0.3 to (V _{INL} + 0.3) | V |
| GP12, GP3 to GA | -0.3 to +0.3 | V |
| Operating Ambient Temperature | -40 to 85 | °C |
| Maximum Junction Temperature | 125 | °C |
| Maximum Power Dissipation TQFN55-40 (Thermal Resistance $\theta_{JA} = 30^{\circ}\text{C/W}$) | 2.7 | W |
| Storage Temperature | -65 to 150 | °C |
| Lead Temperature (Soldering, 10 sec) | 300 | °C |

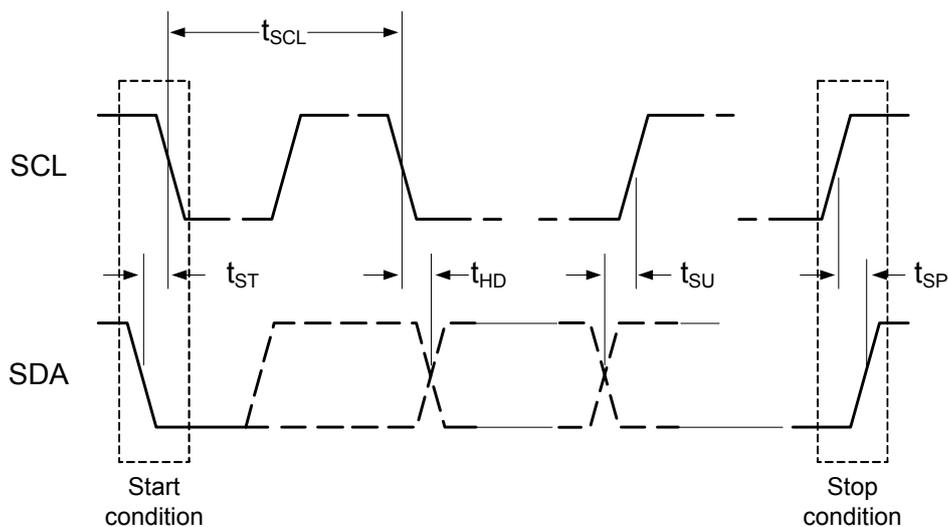
①: Do not exceed these limits to prevent damage to the device. Exposure to absolute maximum rating conditions for long periods may affect device reliability.

I²C INTERFACE ELECTRICAL CHARACTERISTICS

(V_{VSYS} = 3.6V, T_A = 25°C, unless otherwise specified.)

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|--------------------------------------|--|------|-----|------|------|
| SCL, SDA Input Low | V _{VSYS} = 3.1V to 5.5V, T _A = -40°C to 85°C | | | 0.35 | V |
| SCL, SDA Input High | V _{VSYS} = 3.1V to 5.5V, T _A = -40°C to 85°C | 1.55 | | | V |
| SDA Leakage Current | | | | 1 | μA |
| SCL Leakage Current | | | 8 | 18 | μA |
| SDA Output Low | I _{OL} = 5mA | | | 0.35 | V |
| SCL Clock Period, t _{SCL} | | 1.5 | | | μs |
| SDA Data Setup Time, t _{SU} | | 100 | | | ns |
| SDA Data Hold Time, t _{HD} | | 300 | | | ns |
| Start Setup Time, t _{ST} | For Start Condition | 100 | | | ns |
| Stop Setup Time, t _{SP} | For Stop Condition | 100 | | | ns |

Figure 1:
I²C Compatible Serial Bus Timing



GLOBAL REGISTER MAP

| OUTPUT | ADDRESS | | BITS | | | | | | | |
|--------|---------|----------------------|----------|----------|------------|-----------------------|-----------------------|-----------------------|------------|------------|
| | | | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 |
| SYS | 0x00 | NAME | TRST | nSYSMODE | nSYSLEVMSK | nSYSSTAT | SYSLEV[3] | SYSLEV[2] | SYSLEV[1] | SYSLEV[0] |
| | | DEFAULT ^① | 0 | 1 | 0 | R | 0 | 1 | 1 | 1 |
| SYS | 0x01 | NAME | Reserved | Reserved | Reserved | Reserved | SCRATCH | SCRATCH | SCRATCH | SCRATCH |
| | | DEFAULT ^① | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| REG1 | 0x20 | NAME | Reserved | Reserved | VSET1[5] | VSET1[4] | VSET1[3] | VSET1[2] | VSET1[1] | VSET1[0] |
| | | DEFAULT ^① | 0 | 0 | 1 | 1 | 1 | 0 | 0 | 1 |
| REG1 | 0x21 | NAME | Reserved | Reserved | VSET2[5] | VSET2[4] | VSET2[3] | VSET2[2] | VSET2[1] | VSET2[0] |
| | | DEFAULT ^① | 0 | 0 | 1 | 1 | 1 | 0 | 0 | 1 |
| REG1 | 0x22 | NAME | ON | PHASE | MODE | DELAY[2] ^② | DELAY[1] ^② | DELAY[0] ^② | nFLTMSK | OK |
| | | DEFAULT ^① | 0 | 0 | 0 | 0 | 1 | 1 | 0 | R |
| REG2 | 0x30 | NAME | Reserved | Reserved | VSET1[5] | VSET1[4] | VSET1[3] | VSET1[2] | VSET1[1] | VSET1[0] |
| | | DEFAULT ^① | 0 | 0 | 0 | 1 | 0 | 1 | 0 | 0 |
| REG2 | 0x31 | NAME | Reserved | Reserved | VSET2[5] | VSET2[4] | VSET2[3] | VSET2[2] | VSET2[1] | VSET2[0] |
| | | DEFAULT ^① | 0 | 0 | 0 | 1 | 0 | 1 | 0 | 0 |
| REG2 | 0x32 | NAME | ON | PHASE | MODE | DELAY[2] ^② | DELAY[1] ^② | DELAY[0] ^② | nFLTMSK | OK |
| | | DEFAULT ^① | 0 | 0 | 0 | 0 | 1 | 1 | 0 | R |
| REG3 | 0x40 | NAME | Reserved | Reserved | VSET1[5] | VSET1[4] | VSET1[3] | VSET1[2] | VSET1[1] | VSET1[0] |
| | | DEFAULT ^① | 0 | 0 | 0 | 1 | 1 | 0 | 0 | 1 |
| REG3 | 0x41 | NAME | Reserved | Reserved | VSET2[5] | VSET2[4] | VSET2[3] | VSET2[2] | VSET2[1] | VSET2[0] |
| | | DEFAULT ^① | 0 | 0 | 0 | 1 | 1 | 0 | 0 | 1 |
| REG3 | 0x42 | NAME | ON | PWRSTAT | MODE | DELAY[2] ^② | DELAY[1] ^② | DELAY[0] ^② | nFLTMSK | OK |
| | | DEFAULT ^① | 0 | 0 | 0 | 0 | 1 | 1 | 0 | R |
| REG4 | 0x50 | NAME | Reserved | Reserved | VSET[5] | VSET[4] | VSET[3] | VSET[2] | VSET[1] | VSET[0] |
| | | DEFAULT ^① | 0 | 0 | 0 | 1 | 0 | 1 | 0 | 0 |
| REG4 | 0x51 | NAME | ON | DIS | LOWIQ | DELAY[2] ^② | DELAY[1] ^② | DELAY[0] ^② | nFLTMSK | OK |
| | | DEFAULT ^① | 0 | 1 | 0 | 0 | 1 | 1 | 0 | R |
| REG5 | 0x54 | NAME | Reserved | Reserved | VSET[5] | VSET[4] | VSET[3] | VSET[2] | VSET[1] | VSET[0] |
| | | DEFAULT ^① | 0 | 0 | 0 | 1 | 0 | 1 | 0 | 0 |
| REG5 | 0x55 | NAME | ON | DIS | LOWIQ | DELAY[2] ^② | DELAY[1] ^② | DELAY[0] ^② | nFLTMSK | OK |
| | | DEFAULT ^① | 0 | 1 | 0 | 0 | 0 | 0 | 0 | R |
| REG6 | 0x60 | NAME | Reserved | Reserved | VSET[5] | VSET[4] | VSET[3] | VSET[2] | VSET[1] | VSET[0] |
| | | DEFAULT ^① | 0 | 0 | 0 | 1 | 0 | 1 | 0 | 0 |
| REG6 | 0x61 | NAME | ON | DIS | LOWIQ | DELAY[2] ^② | DELAY[1] ^② | DELAY[0] ^② | nFLTMSK | OK |
| | | DEFAULT ^① | 0 | 1 | 0 | 0 | 1 | 1 | 0 | R |
| REG7 | 0x64 | NAME | Reserved | Reserved | VSET[5] | VSET[4] | VSET[3] | VSET[2] | VSET[1] | VSET[0] |
| | | DEFAULT ^① | 0 | 0 | 1 | 1 | 1 | 0 | 0 | 1 |
| REG7 | 0x65 | NAME | ON | DIS | LOWIQ | DELAY[2] ^② | DELAY[1] ^② | DELAY[0] ^② | nFLTMSK | OK |
| | | DEFAULT ^① | 0 | 1 | 0 | 1 | 0 | 0 | 0 | R |
| APCH | 0x70 | NAME | Reserved | Reserved | Reserved | Reserved | Reserved | Reserved | Reserved | Reserved |
| | | DEFAULT ^① | 0 | 1 | 0 | 1 | 0 | 0 | 0 | 0 |
| APCH | 0x71 | NAME | SUSCHG | Reserved | TOTTIMO[1] | TOTTIMO[0] | PRETIMO[1] | PRETIMO[0] | OVPSSET[1] | OVPSSET[0] |
| | | DEFAULT ^① | 0 | 0 | 1 | 0 | 1 | 0 | 0 | 0 |
| APCH | 0x78 | NAME | TIMRSTAT | TEMPSTAT | INSTAT | CHGSTAT | TIMRDAT | TEMPDAT | INDAT | CHGDAT |
| | | DEFAULT ^① | 0 | 0 | 0 | 0 | R | R | R | R |
| APCH | 0x79 | NAME | TIMRTOT | TEMPIN | INCON | CHGEOCIN | TIMRPRE | TEMPOUT | INDIS | CHGEOCOUT |
| | | DEFAULT ^① | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| APCH | 0x7A | NAME | Reserved | Reserved | CSTATE[0] | CSTATE[1] | Reserved | Reserved | ACINSTAT | Reserved |
| | | DEFAULT ^① | 0 | 0 | R | R | R | R | R | R |

①: Default values of ACT8937QJ21C-T.

②: Regulator turn-on delay bits. Automatically cleared to default values when the input power is removed or falls below the system UVLO.

REGISTER AND BIT DESCRIPTIONS

Table 1:
Global Register Map

| OUTPUT | ADDRESS | BIT | NAME | ACCESS | DESCRIPTION |
|--------|---------|-------|------------|--------|---|
| SYS | 0x00 | [7] | TRST | R/W | Reset Timer Setting. Defines the reset timeout threshold. See <i>nRSTO Output</i> section for more information. |
| SYS | 0x00 | [6] | nSYSMODE | R/W | SYSLEV Mode Select. Defines the response to the SYSLEV voltage detector, 1: Generate an interrupt when VSYS falls below the programmed SYSLEV threshold, 0: automatic shutdown when VSYS falls below the programmed SYSLEV threshold. |
| SYS | 0x00 | [5] | nSYSLEVMSK | R/W | System Voltage Level Interrupt Mask. Disabled interrupt by default, set to 1 to enable this interrupt. See the <i>Programmable System Voltage Monitor</i> section for more information |
| SYS | 0x00 | [4] | nSYSSTAT | R | System Voltage Status. Value is 1 when VSYS is higher than the SYSLEV voltage threshold, value is 0 when VSYS is lower than the system voltage detection threshold. |
| SYS | 0x00 | [3:0] | SYSLEV | R/W | System Voltage Detect Threshold. Defines the SYSLEV voltage threshold. See the <i>Programmable System Voltage Monitor</i> section for more information. |
| SYS | 0x01 | [7:4] | - | R/W | Reserved. |
| SYS | 0x01 | [3:0] | SCRATCH | R/W | Scratchpad Bits. Non-functional bits, maybe be used by user to store system status information. Volatile bits, which are cleared upon system shutdown. |
| REG1 | 0x20 | [7:6] | - | R | Reserved. |
| REG1 | 0x20 | [5:0] | VSET1 | R/W | Primary Output Voltage Selection. Valid when VSEL is driven low. See the <i>Output Voltage Programming</i> section for more information. |
| REG1 | 0x21 | [7:6] | - | R | Reserved. |
| REG1 | 0x21 | [5:0] | VSET2 | R/W | Secondary Output Voltage Selection. Valid when VSEL is driven high. See the <i>Output Voltage Programming</i> section for more information. |
| REG1 | 0x22 | [7] | ON | R/W | Regulator Enable Bit. Set bit to 1 to enable the regulator, clear bit to 0 to disable the regulator. |
| REG1 | 0x22 | [6] | PHASE | R/W | Regulator Phase Control. Set bit to 1 for regulator to operate 180° out of phase with the oscillator, clear bit to 0 for regulator to operate in phase with the oscillator. |
| REG1 | 0x22 | [5] | MODE | R/W | Regulator Mode Select. Set bit to 1 for fixed-frequency PWM under all load conditions, clear bit to 0 to transit to power-savings mode under light-load conditions. |
| REG1 | 0x22 | [4:2] | DELAY | R/W | Regulator Turn-On Delay Control. See the <i>REG1, REG2, REG3 Turn-on Delay</i> section for more information. |
| REG1 | 0x22 | [1] | nFLTMSK | R/W | Regulator Fault Mask Control. Set bit to 1 enable to fault-interrupts, clear bit to 0 to disable fault-interrupts. |
| REG1 | 0x22 | [0] | OK | R | Regulator Power-OK Status. Value is 1 when output voltage exceeds the power-OK threshold, value is 0 otherwise. |
| REG2 | 0x30 | [7:6] | - | R | Reserved. |
| REG2 | 0x30 | [5:0] | VSET1 | R/W | Primary Output Voltage Selection. Valid when VSEL is driven low. See the <i>Output Voltage Programming</i> section for more information. |
| REG2 | 0x31 | [7:6] | - | R | Reserved. |

REGISTER AND BIT DESCRIPTIONS CONT'D

| OUTPUT | ADDRESS | BIT | NAME | ACCESS | DESCRIPTION |
|--------|---------|-------|---------|--------|---|
| REG2 | 0x31 | [5:0] | VSET2 | R/W | Secondary Output Voltage Selection. Valid when VSEL is driven high. See the <i>Output Voltage Programming</i> section for more information. |
| REG2 | 0x32 | [7] | ON | R/W | Regulator Enable Bit. Set bit to 1 to enable the regulator, clear bit to 0 to disable the regulator. |
| REG2 | 0x32 | [6] | PHASE | R/W | Regulator Phase Control. Set bit to 1 for regulator to operate 180° out of phase with the oscillator, clear bit to 0 for regulator to operate in phase with the oscillator. |
| REG2 | 0x32 | [5] | MODE | R/W | Regulator Mode Select. Set bit to 1 for fixed-frequency PWM under all load conditions, clear bit to 0 to transit to power-savings mode under light-load conditions. |
| REG2 | 0x32 | [4:2] | DELAY | R/W | Regulator Turn-On Delay Control. See the <i>REG1, REG2, REG3 Turn-on Delay</i> section for more information. |
| REG2 | 0x32 | [1] | nFLTMSK | R/W | Regulator Fault Mask Control. Set bit to 1 enable to fault-interrupts, clear bit to 0 to disable fault-interrupts. |
| REG2 | 0x32 | [0] | OK | R | Regulator Power-OK Status. Value is 1 when output voltage exceeds the power-OK threshold, value is 0 otherwise. |
| REG3 | 0x40 | [7:6] | - | R | Reserved. |
| REG3 | 0x40 | [5:0] | VSET1 | R/W | Primary Output Voltage Selection. Valid when VSEL is driven low. See the <i>Output Voltage Programming</i> section for more information. |
| REG3 | 0x41 | [7:6] | - | R | Reserved. |
| REG3 | 0x41 | [5:0] | VSET2 | R/W | Secondary Output Voltage Selection. Valid when VSEL is driven high. See the <i>Output Voltage Programming</i> section for more information. |
| REG3 | 0x42 | [7] | ON | R/W | Regulator Enable Bit. Set bit to 1 to enable the regulator, clear bit to 0 to disable the regulator. |
| REG3 | 0x42 | [6] | PWRSTAT | R/W | Configures regulator behavior with respect to the nPBIN input. Set bit to 0 to enable regulator when nPBIN is asserted. |
| REG3 | 0x42 | [5] | MODE | R/W | Regulator Mode Select. Set bit to 1 for fixed-frequency PWM under all load conditions, clear bit to 0 to transit to power-savings mode under light-load conditions. |
| REG3 | 0x42 | [4:2] | DELAY | R/W | Regulator Turn-On Delay Control. See the <i>REG1, REG2, REG3 Turn-on Delay</i> section for more information. |
| REG3 | 0x42 | [1] | nFLTMSK | R/W | Regulator Fault Mask Control. Set bit to 1 enable to fault-interrupts, clear bit to 0 to disable fault-interrupts. |
| REG3 | 0x42 | [0] | OK | R | Regulator Power-OK Status. Value is 1 when output voltage exceeds the power-OK threshold, value is 0 otherwise. |
| REG4 | 0x50 | [7:6] | - | R | Reserved. |
| REG4 | 0x50 | [5:0] | VSET | R/W | Output Voltage Selection. See the <i>Output Voltage Programming</i> section for more information. |
| REG4 | 0x51 | [7] | ON | R/W | Regulator Enable Bit. Set bit to 1 to enable the regulator, clear bit to 0 to disable the regulator. |
| REG4 | 0x51 | [6] | DIS | R/W | Output Discharge Control. When activated, discharges LDO output to GA through 1.5kΩ when in shutdown. Set bit to 1 to enable output voltage discharge in shutdown, clear bit to 0 to disable this function. |
| REG4 | 0x51 | [5] | LOWIQ | R/W | LDO Low-IQ Mode Control. Set bit to 1 for low-power operating mode, clear bit to 0 for normal mode. |
| REG4 | 0x51 | [4:2] | DELAY | R/W | Regulator Turn-On Delay Control. See the <i>REG4, REG5, REG6, REG7 Turn-on Delay</i> section for more information. |
| REG4 | 0x51 | [1] | nFLTMSK | R/W | Regulator Fault Mask Control. Set bit to 1 enable to fault-interrupts, clear bit to 0 to disable fault-interrupts. |

REGISTER AND BIT DESCRIPTIONS CONT'D

| OUTPUT | ADDRESS | BIT | NAME | ACCESS | DESCRIPTION |
|--------|---------|-------|---------|--------|---|
| REG4 | 0x51 | [0] | OK | R | Regulator Power-OK Status. Value is 1 when output voltage exceeds the power-OK threshold, value is 0 otherwise. |
| REG5 | 0x54 | [7:6] | - | R | Reserved. |
| REG5 | 0x54 | [5:0] | VSET | R/W | Output Voltage Selection. See the <i>Output Voltage Programming</i> section for more information. |
| REG5 | 0x55 | [7] | ON | R/W | Regulator Enable Bit. Set bit to 1 to enable the regulator, clear bit to 0 to disable the regulator. |
| REG5 | 0x55 | [6] | DIS | R/W | Output Discharge Control. When activated, discharges LDO output to GA through 1.5kΩ when in shutdown. Set bit to 1 to enable output voltage discharge in shutdown, clear bit to 0 to disable this function. |
| REG5 | 0x55 | [5] | LOWIQ | R/W | LDO Low-IQ Mode Control. Set bit to 1 for low-power operating mode, clear bit to 0 for normal mode. |
| REG5 | 0x55 | [4:2] | DELAY | R/W | Regulator Turn-On Delay Control. See the <i>REG4, REG5, REG6, REG7 Turn-on Delay</i> section for more information. |
| REG5 | 0x55 | [1] | nFLTMSK | R/W | Regulator Fault Mask Control. Set bit to 1 enable to fault-interrupts, clear bit to 0 to disable fault-interrupts. |
| REG5 | 0x55 | [0] | OK | R | Regulator Power-OK Status. Value is 1 when output voltage exceeds the power-OK threshold, value is 0 otherwise. |
| REG6 | 0x60 | [7:6] | - | R | Reserved. |
| REG6 | 0x60 | [5:0] | VSET | R/W | Output Voltage Selection. See the <i>Output Voltage Programming</i> section for more information. |
| REG6 | 0x61 | [7] | ON | R/W | Regulator Enable Bit. Set bit to 1 to enable the regulator, clear bit to 0 to disable the regulator. |
| REG6 | 0x61 | [6] | DIS | R/W | Output Discharge Control. When activated, discharges LDO output to GA through 1.5kΩ when in shutdown. Set bit to 1 to enable output voltage discharge in shutdown, clear bit to 0 to disable this function. |
| REG6 | 0x61 | [5] | LOWIQ | R/W | LDO Low-IQ Mode Control. Set bit to 1 for low-power operating mode, clear bit to 0 for normal mode. |
| REG6 | 0x61 | [4:2] | DELAY | R/W | Regulator Turn-On Delay Control. See the <i>REG4, REG5, REG6, REG7 Turn-on Delay</i> section for more information. |
| REG6 | 0x61 | [1] | nFLTMSK | R/W | Regulator Fault Mask Control. Set bit to 1 enable to fault-interrupts, clear bit to 0 to disable fault-interrupts. |
| REG6 | 0x61 | [0] | OK | R | Regulator Power-OK Status. Value is 1 when output voltage exceeds the power-OK threshold, value is 0 otherwise. |
| REG7 | 0x64 | [7:6] | - | R | Reserved. |
| REG7 | 0x64 | [5:0] | VSET | R/W | Output Voltage Selection. See the <i>Output Voltage Programming</i> section for more information. |
| REG7 | 0x65 | [7] | ON | R/W | Regulator Enable Bit. Set bit to 1 to enable the regulator, clear bit to 0 to disable the regulator. |
| REG7 | 0x65 | [6] | DIS | R/W | Output Discharge Control. When activated, discharges LDO output to GA through 1.5kΩ when in shutdown. Set bit to 1 to enable output voltage discharge in shutdown, clear bit to 0 to disable this function. |
| REG7 | 0x65 | [5] | LOWIQ | R/W | LDO Low-IQ Mode Control. Set bit to 1 for low-power operating mode, clear bit to 0 for normal mode. |
| REG7 | 0x65 | [4:2] | DELAY | R/W | Regulator Turn-On Delay Control. See the <i>REG4, REG5, REG6, REG7 Turn-on Delay</i> section for more information. |
| REG7 | 0x65 | [1] | nFLTMSK | R/W | Regulator Fault Mask Control. Set bit to 1 enable to fault-interrupts, clear bit to 0 to disable fault-interrupts. |

REGISTER AND BIT DESCRIPTIONS CONT'D

| OUTPUT | ADDRESS | BIT | NAME | ACCESS | DESCRIPTION |
|--------|---------|-------|-----------|--------|--|
| REG7 | 0x65 | [0] | OK | R | Regulator Power-OK Status. Value is 1 when output voltage exceeds the power-OK threshold, value is 0 otherwise. |
| APCH | 0x70 | [7:0] | - | R/W | Reserved. |
| APCH | 0x71 | [7] | SUSCHG | R/W | Charge Suspend Control Input. Set bit to 1 to suspend charging, clear bit to 0 to allow charging to resume. |
| APCH | 0x71 | [6] | - | R/W | Reserved. |
| APCH | 0x71 | [5:4] | TOTTIMO | R/W | Total Charge Timeout Selection. See the <i>Charge Safety Timers</i> section for more information. |
| APCH | 0x71 | [3:2] | PRETIMO | R/W | Precondition Charge Timeout Selection. See the <i>Charge Safety Timers</i> section for more information. |
| APCH | 0x71 | [1:0] | OVPSET | R/W | Input Over-Voltage Protection Threshold Selection. See the <i>Input Over-Voltage Protection</i> section for more information. |
| APCH | 0x78 | [7] | TIMRSTAT | R/W | Charge Timeout Interrupt Status. See the <i>Charge Safety Timers</i> section for more information. |
| APCH | 0x78 | [6] | TEMPSTAT | R/W | Temperature Interrupt Status. See the <i>Battery Temperature Monitoring</i> section for more information. |
| APCH | 0x78 | [5] | INSTAT | R/W | Input Voltage Interrupt Status. See the <i>Charge Current Programming</i> section for more information. |
| APCH | 0x78 | [4] | CHGSTAT | R/W | Charge State Interrupt Status. See the <i>State Machine Interrupts</i> section for more information. |
| APCH | 0x78 | [3] | TIMRDAT | R | Charge Timer Interrupt Status. Value is 1 when precondition timeout or total charge timeout fault occurs. Value is 0 in other case. |
| APCH | 0x78 | [2] | TEMPDAT | R | Temperature Status. Value is 1 when battery temperature is outside of valid range. Value is 0 when battery temperature is inside of valid range. |
| APCH | 0x78 | [1] | INDAT | R | Input Voltage Status. Value is 1 when a valid input at CHGIN is present. Value is 0 when a valid input at CHGIN is not present. |
| APCH | 0x78 | [0] | CHGDAT | R | Charge State Status. Value is 1 when in END-OF-CHARGE State. Value is 0 when in other state. |
| APCH | 0x79 | [7] | TIMRTOT | R/W | Charge Timer Interrupt Control. See the <i>Charge Safety Timers</i> section for more information. |
| APCH | 0x79 | [6] | TEMPIN | R/W | Temperature Interrupt Control. See the <i>Battery Temperature Monitoring</i> section for more information. |
| APCH | 0x79 | [5] | INCON | R/W | Input Voltage Interrupt Control. See the <i>Charge Current Programming</i> section for more information. |
| APCH | 0x79 | [4] | CHGEOCIN | R/W | Charge State Interrupt Control. See the <i>State Machine Interrupts</i> section for more information. |
| APCH | 0x79 | [3] | TIMRPRE | R/W | Charge Timer Interrupt Control. See the <i>Charge Safety Timers</i> section for more information. |
| APCH | 0x79 | [2] | TEMPOUT | R/W | Temperature Interrupt Control. See the <i>Battery Temperature Monitoring</i> section for more information. |
| APCH | 0x79 | [1] | INDIS | R/W | Input Voltage Interrupt Control. See the <i>Charge Current Programming</i> section for more information. |
| APCH | 0x79 | [0] | CHGEOCOUT | R/W | Charge State Interrupt Control. See the <i>State Machine Interrupts</i> section for more information. |
| APCH | 0x7A | [7:6] | - | R | Reserved. |

REGISTER AND BIT DESCRIPTIONS CONT'D

| OUTPUT | ADDRESS | BIT | NAME | ACCESS | DESCRIPTION |
|--------|---------|-------|----------|--------|--|
| APCH | 0x7A | [5:4] | CSTATE | R | Charge State. Values indicate the current charging state. See the <i>State Machine Interrupts</i> section for more information. |
| APCH | 0x7A | [3:2] | - | R | Reserved. |
| APCH | 0x7A | [1] | ACINSTAT | R | ACIN Status. Indicates the state of the ACIN input, typically in order to identify the type of input supply connected. Value is 1 when ACIN is above the 1.2V precision threshold, value is 0 when ACIN is below this threshold. |
| APCH | 0x7A | [0] | - | R | Reserved. |

SYSTEM CONTROL ELECTRICAL CHARACTERISTICS

($V_{SYS} = 3.6V$, $T_A = 25^\circ C$, unless otherwise specified.)

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|---------------------------------------|---|------|------------------|------|------------|
| Input Voltage Range | | 2.7 | | 5.5 | V |
| UVLO Threshold Voltage | VSYS Rising | 2.2 | 2.45 | 2.65 | V |
| UVLO Hysteresis | VSYS Falling | | 200 | | mV |
| Supply Current | REG1 and REG5 Enabled. REG2, REG3, REG4, REG6 and REG7 Disabled | | 190 | | μA |
| | REG1, REG2, REG3, REG4 and REG5 Enabled. REG6 and REG7 Disabled | | 340 | | |
| | REG1, REG2, REG3, REG4, REG5, REG6 and REG7 Enabled | | 420 | | |
| Shutdown Supply Current | All Regulators Disabled | | 8 | 18 | μA |
| Oscillator Frequency | | 1.8 | 2 | 2.2 | MHz |
| Logic High Input Voltage ^① | | 1.4 | | | V |
| Logic Low Input Voltage | | | | 0.4 | V |
| Leakage Current | $V_{nIRQ} = V_{nRSTO} = 4.2V$ | | | 1 | μA |
| LBI Threshold Voltage | VBAT Falling | 1.03 | 1.2 | 1.31 | V |
| LBI Hysteresis Threshold | VBAT Rising | | 200 | | mV |
| Low Level Output Voltage ^② | $I_{SINK} = 5mA$ | | | 0.35 | V |
| nRSTO Delay | | | 260 ^③ | | ms |
| Thermal Shutdown Temperature | Temperature rising | | 160 | | $^\circ C$ |
| Thermal Shutdown Hysteresis | | | 20 | | $^\circ C$ |

①: PWRHLD, PWREN, VSEL are logic inputs

②: nLBO, nPBSTAT, nIRQ, nRSTO are open drain outputs

③: Typical value shown. Actual value may vary from 227.9ms to 291.2ms.

STEP-DOWN DC/DC ELECTRICAL CHARACTERISTICS

($V_{VP1} = V_{VP2} = V_{VP3} = 3.6V$, $T_A = 25^\circ C$, unless otherwise specified.)

| PARAMETER | CONDITIONS | MIN | TYP | MAX | UNIT |
|--------------------------|--|------|-----------------------------|------|-------------|
| Operating Voltage Range | | 2.7 | | 5.5 | V |
| UVLO Threshold | Input Voltage Rising | 2.5 | 2.6 | 2.7 | V |
| UVLO Hysteresis | Input Voltage Falling | | 100 | | mV |
| Quiescent Supply Current | Regulator Enabled | | 65 | 90 | μA |
| Shutdown Current | $V_{VP} = 5.5V$, Regulator Disabled | | 0 | 1 | μA |
| Output Voltage Accuracy | $V_{OUT} \geq 1.2V$, $I_{OUT} = 10mA$ | -1% | $V_{NOM}^{\textcircled{1}}$ | 1% | V |
| | $V_{OUT} < 1.2V$, $I_{OUT} = 10mA$ | -2% | $V_{NOM}^{\textcircled{1}}$ | 2% | |
| Line Regulation | $V_{VP} = \text{Max}(V_{NOM}^{\textcircled{1}} + 1, 3.2V)$ to 5.5V | | 0.15 | | %/V |
| Load Regulation | $I_{OUT} = 10mA$ to $I_{MAX}^{\textcircled{2}}$ | | 0.0017 | | %/mA |
| Power Good Threshold | V_{OUT} Rising | | 93 | | % V_{NOM} |
| Power Good Hysteresis | V_{OUT} Falling | | 2 | | % V_{NOM} |
| Oscillator Frequency | $V_{OUT} \geq 20\%$ of V_{NOM} | 1.8 | 2 | 2.2 | MHz |
| | $V_{OUT} = 0V$ | | 500 | | kHz |
| Soft-Start Period | | | 400 | | μs |
| Minimum On-Time | | | 75 | | ns |
| REG1 | | | | | |
| Maximum Output Current | | 1.1 | | | A |
| Current Limit | | 1.55 | 1.80 | 2.05 | A |
| PMOS On-Resistance | $I_{SW1} = -100mA$ | | 0.16 | | Ω |
| NMOS On-Resistance | $I_{SW1} = 100mA$ | | 0.16 | | Ω |
| SW1 Leakage Current | $V_{VP1} = 5.5V$, $V_{SW1} = 0$ or 5.5V | | 0 | 1 | μA |
| REG2 | | | | | |
| Maximum Output Current | | 1.1 | | | A |
| Current Limit | | 1.55 | 1.80 | 2.05 | A |
| PMOS On-Resistance | $I_{SW2} = -100mA$ | | 0.16 | | Ω |
| NMOS On-Resistance | $I_{SW2} = 100mA$ | | 0.16 | | Ω |
| SW2 Leakage Current | $V_{VP2} = 5.5V$, $V_{SW2} = 0$ or 5.5V | | 0 | 1 | μA |
| REG3 | | | | | |
| Maximum Output Current | | 1.2 | | | A |
| Current Limit | | 1.55 | 1.80 | 2.05 | A |
| PMOS On-Resistance | $I_{SW3} = -100mA$ | | 0.16 | | Ω |
| NMOS On-Resistance | $I_{SW3} = 100mA$ | | 0.16 | | Ω |
| SW3 Leakage Current | $V_{VP3} = 5.5V$, $V_{SW3} = 0$ or 5.5V | | 0 | 1 | μA |

$\textcircled{1}$: V_{NOM} refers to the nominal output voltage level for V_{OUT} as defined by the *Ordering Information* section.

$\textcircled{2}$: I_{MAX} Maximum Output Current.

LOW-NOISE LDO ELECTRICAL CHARACTERISTICS

($V_{INL} = 3.6V$, $C_{OUT4} = C_{OUT5} = 1.5\mu F$, $C_{OUT6} = C_{OUT7} = 2.2\mu F$, $LOWIQ[] = [0]$, $T_A = 25^\circ C$, unless otherwise specified.)

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|------------------------------|--|-----|-----------------------------|-----|---------------|
| Operating Voltage Range | | 2.5 | | 5.5 | V |
| Output Voltage Accuracy | $V_{OUT} \geq 1.2V$, $T_A = 25^\circ C$, $I_{OUT} = 10mA$ | -1% | $V_{NOM}^{\textcircled{1}}$ | 2% | V |
| | $V_{OUT} < 1.2V$, $T_A = 25^\circ C$, $I_{OUT} = 10mA$ | -2% | $V_{NOM}^{\textcircled{1}}$ | 4% | |
| Line Regulation | $V_{INL} = \text{Max}(V_{OUT} + 0.5V, 3.6V)$ to 5.5V $LOWIQ[] = [0]$ | | 0.05 | | mV/V |
| | $V_{INL} = \text{Max}(V_{OUT} + 0.5V, 3.6V)$ to 5.5V $LOWIQ[] = [1]$ | | 0.5 | | |
| Load Regulation | $I_{OUT} = 1mA$ to $IMAX^{\textcircled{2}}$ | | 0.08 | | V/A |
| Power Supply Rejection Ratio | $f = 1kHz$, $I_{OUT} = 20mA$, $V_{OUT} = 1.2V$ | | 75 | | dB |
| | $f = 10kHz$, $I_{OUT} = 20mA$, $V_{OUT} = 1.2V$ | | 65 | | |
| Supply Current per Output | Regulator Enabled, $LOWIQ[] = [0]$ | | 37 | 60 | μA |
| | Regulator Enabled, $LOWIQ[] = [1]$ | | 31 | 52 | |
| | Regulator Disabled | | 0 | 1 | |
| Soft-Start Period | $V_{OUT} = 2.9V$ | | 140 | | μs |
| Power Good Threshold | V_{OUT} Rising | | 89 | | % |
| Power Good Hysteresis | V_{OUT} Falling | | 3 | | % |
| Output Noise | $I_{OUT} = 20mA$, $f = 10Hz$ to 100kHz, $V_{OUT} = 1.2V$ | | 50 | | μV_{RMS} |
| Discharge Resistance | LDO Disabled, $DIS[] = 1$ | | 1.5 | | k Ω |
| REG4 | | | | | |
| Dropout Voltage ^③ | $I_{OUT} = 80mA$, $V_{OUT} > 3.1V$ | | 90 | 180 | mV |
| Maximum Output Current | | 150 | | | mA |
| Current Limit ^③ | $V_{OUT} = 95\%$ of regulation voltage | 200 | | | mA |
| Stable C_{OUT4} Range | | 1.5 | | 20 | μF |
| REG5 | | | | | |
| Dropout Voltage | $I_{OUT} = 80mA$, $V_{OUT} > 3.1V$ | | 140 | 280 | mV |
| Maximum Output Current | | 150 | | | mA |
| Current Limit | $V_{OUT} = 95\%$ of regulation voltage | 200 | | | mA |
| Stable C_{OUT5} Range | | 1.5 | | 20 | μF |
| REG6 | | | | | |
| Dropout Voltage | $I_{OUT} = 120mA$, $V_{OUT} > 3.1V$ | | 90 | 180 | mV |
| Maximum Output Current | | 250 | | | mA |
| Current Limit | $V_{OUT} = 95\%$ of regulation voltage | 300 | | | mA |
| Stable C_{OUT6} Range | | 2.2 | | 20 | μF |
| REG7 | | | | | |
| Dropout Voltage | $I_{OUT} = 120mA$, $V_{OUT} > 3.1V$ | | 140 | 280 | mV |
| Maximum Output Current | | 250 | | | mA |
| Current Limit | $V_{OUT} = 95\%$ of regulation voltage | 300 | | | mA |
| Stable C_{OUT7} Range | | 2.2 | | 20 | μF |

①: V_{NOM} refers to the nominal output voltage level for V_{OUT} as defined by the *Ordering Information* section.

②: $IMAX$ Maximum Output Current.

③: Dropout Voltage is defined as the differential voltage between input and output when the output voltage drops 100mV below the regulation voltage (for 3.1V output voltage or higher).

ActivePath™ CHARGER ELECTRICAL CHARACTERISTICS

($V_{CHGIN} = 5.0V$, $T_A = 25^\circ C$, unless otherwise specified.)

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|--|---|------|------|------|----------|
| ActivePath | | | | | |
| CHGIN Operating Voltage Range | | 4.35 | | 6.0 | V |
| CHGIN UVLO Threshold | CHGIN Voltage Rising | 3.1 | 3.5 | 3.9 | V |
| CHGIN UVLO Hysteresis | CHGIN Voltage Falling | | 0.5 | | V |
| CHGIN OVP Threshold | CHGIN Voltage Rising | 6.0 | 6.6 | 7.2 | V |
| CHGIN OVP Hysteresis | CHGIN Voltage Falling | | 0.4 | | V |
| CHGIN Supply Current | $V_{CHGIN} < V_{UVLO}$ | | 35 | 70 | μA |
| | $V_{CHGIN} < V_{BAT} + 50mV$, $V_{CHGIN} > V_{UVLO}$ | | 100 | 200 | μA |
| | $V_{CHGIN} > V_{BAT} + 150mV$, $V_{CHGIN} > V_{UVLO}$ Charger disabled, $I_{V_{SYS}} = 0mA$ | | 1.3 | 2.0 | mA |
| CHGIN to VSYS On-Resistance | $I_{V_{SYS}} = 100mA$ | | 0.3 | | Ω |
| CHGIN to VSYS Current Limit | ACIN = VSYS | 1.5 | 2 | | A |
| | ACIN = GA, CHGLEV = GA | 80 | 90 | 100 | mA |
| | ACIN = GA, CHGLEV = VSYS | 400 | 450 | 500 | |
| VSYS REGULATION | | | | | |
| VSYS Regulated Voltage | $I_{V_{SYS}} = 10mA$ | 4.45 | 4.6 | 4.8 | V |
| nSTAT OUTPUT | | | | | |
| nSTAT Sink current | $V_{nSTAT} = 2V$ | 4 | 8 | 12 | mA |
| nSTAT Leakage Current | $V_{nSTAT} = 4.2V$ | | | 1 | μA |
| ACIN AND CHGLEV INPUTS | | | | | |
| CHGLEV Logic High Input Voltage | | 1.4 | | | V |
| CHGLEV Logic Low Input Voltage | | | | 0.4 | V |
| CHGLEV Leakage Current | $V_{CHGLEV} = 4.2V$ | | | 1 | μA |
| ACIN Voltage Thresholds | ACIN voltage rising | 1.03 | 1.2 | 1.31 | V |
| ACIN Hysteresis voltage threshold | ACIN voltage falling | | 200 | | mV |
| ACIN Leakage Current | $V_{ACIN} = 4.2V$ | | | 1 | μA |
| TH INPUT | | | | | |
| TH Pull-Up Current | $V_{CHGIN} > V_{BAT} + 100mV$, Hysteresis = 50mV | 91 | 102 | 110 | μA |
| V_{TH} Upper Temperature Voltage Threshold (V_{THH}) | Hot Detect NTC Thermistor | 2.44 | 2.51 | 2.58 | V |
| V_{TH} Lower Temperature Voltage Threshold (V_{THL}) | Cold Detect NTC Thermistor | 0.47 | 0.50 | 0.53 | V |
| V_{TH} Hysteresis | Upper and Lower Thresholds | | 30 | | mV |

ActivePath™ CHARGER ELECTRICAL CHARACTERISTICS CONT'D

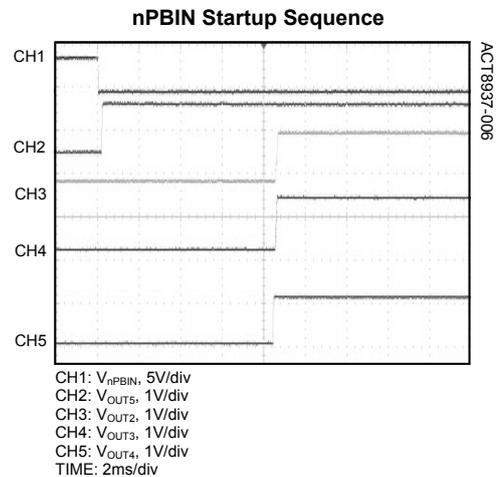
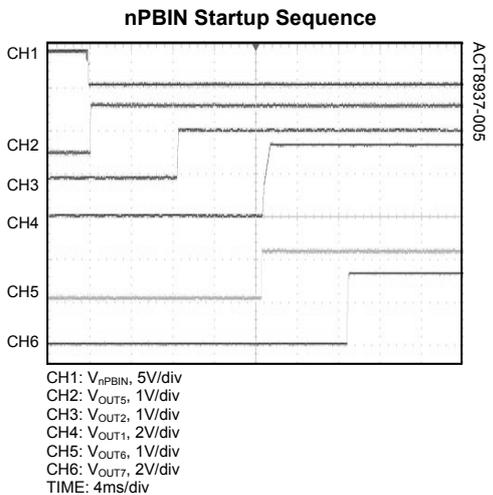
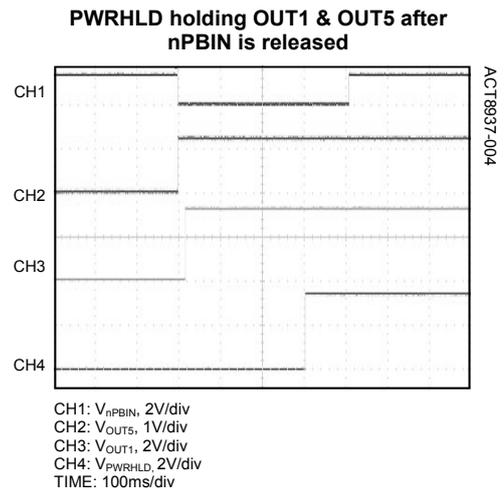
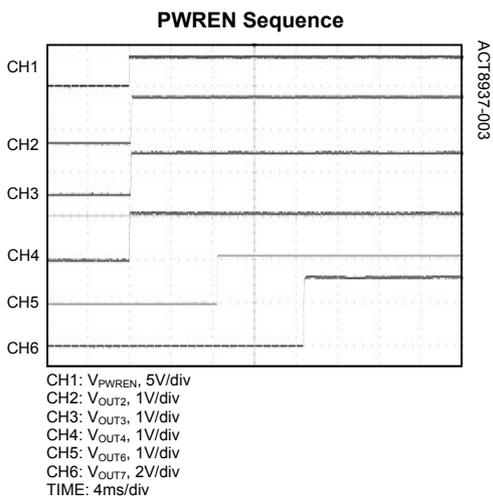
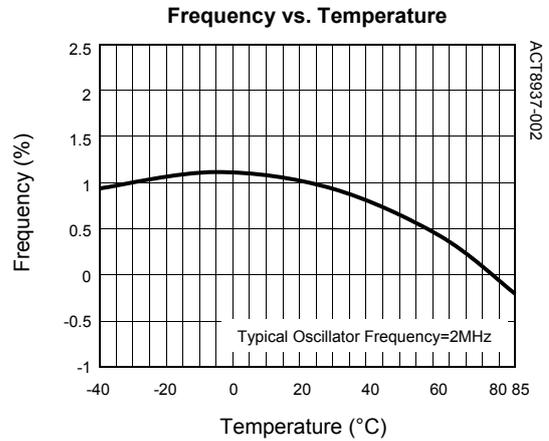
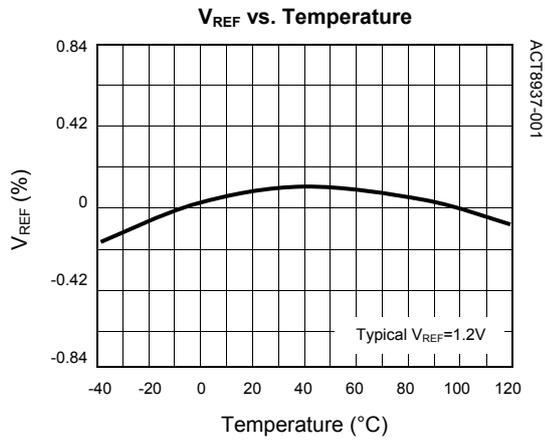
(V_{CHGIN} = 5.0V, T_A = 25°C, unless otherwise specified.)

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT | |
|-----------------------------------|---|----------------------------|----------------------|-------------------------------|------|----|
| CHARGER | | | | | | |
| BAT Reverse Leakage Current | V _{CHGIN} = 0V, V _{BAT} = 4.2V, I _{VSYS} = 0mA | | 8 | | μA | |
| BAT to VSYS On-Resistance | | | 70 | | mΩ | |
| ISET Pin Voltage | Fast Charge | | 1.2 | | V | |
| | Precondition | | 0.13 | | | |
| Charge Termination Voltage | T _A = -20°C to 70°C | 4.179 | 4.2 | 4.221 | V | |
| | T _A = -40°C to 85°C | 4.170 | 4.2 | 4.230 | | |
| Charge Current | V _{BAT} = 3.8V R _{ISET} = 6.8K | ACIN = VSYS, CHGLEV = VSYS | -10% | I _{CHG} ^① | +10% | mA |
| | | ACIN = VSYS, CHGLEV = GA | -10% | I _{CHG} /5 | +10% | |
| | | ACIN = GA, CHGLEV = VSYS | 400 | 450 | 500 | |
| | | ACIN = GA, CHGLEV = GA | 80 | 90 | 100 | |
| Precondition Charge Current | V _{BAT} = 2.7V R _{ISET} = 6.8K | ACIN = VSYS, CHGLEV = VSYS | 10% I _{CHG} | | mA | |
| | | ACIN = VSYS, CHGLEV = GA | 10% I _{CHG} | | | |
| | | ACIN = GA, CHGLEV = VSYS | 45 | | | |
| | | ACIN = GA, CHGLEV = GA | 45 | | | |
| Precondition Threshold Voltage | V _{BAT} Voltage Rising | 2.75 | 2.85 | 3.0 | V | |
| Precondition Threshold Hysteresis | V _{BAT} Voltage Falling | | 150 | | mV | |
| END-OF-CHARGE Current Threshold | V _{BAT} = 4.15V | ACIN = VSYS, CHGLEV = VSYS | 10% I _{CHG} | | mA | |
| | | ACIN = VSYS, CHGLEV = GA | 10% I _{CHG} | | | |
| | | ACIN = GA, CHGLEV = VSYS | 45 | | | |
| | | ACIN = GA, CHGLEV = GA | 45 | | | |
| Charge Restart Threshold | V _{VSYS} - V _{BAT} , V _{BAT} Falling | 190 | 205 | 220 | V | |
| Precondition Safety Timer | PRETIMO[] = 10 | | 80 | | min | |
| Total Safety Timer | TOTTIMO[] = 10 | | 5 | | hr | |
| Thermal Regulation Threshold | | | 100 | | °C | |

①: R_{ISET} (kΩ) = 2336 × (1V/I_{CHG} (mA)) - 0.205

TYPICAL PERFORMANCE CHARACTERISTICS

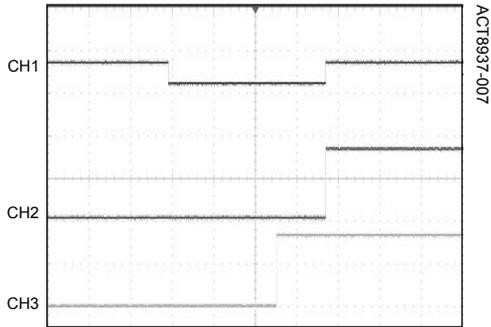
($V_{SYS} = 3.6V$, $T_A = 25^\circ C$, unless otherwise specified.)



TYPICAL PERFORMANCE CHARACTERISTICS CONT'D

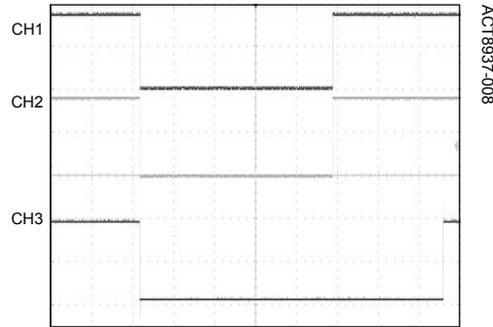
(T_A = 25°C, unless otherwise specified.)

Push-Button Response (First Power-Up)



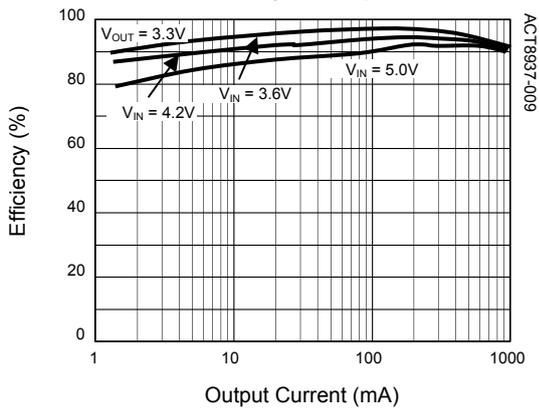
CH1: V_{nPBIN}, 2V/div
CH2: V_{nPBSTAT}, 2V/div
CH3: V_{nRSTO}, 2V/div
TIME: 100ms/div
nPBIN Resistor = 50kΩ

Manual Reset Response

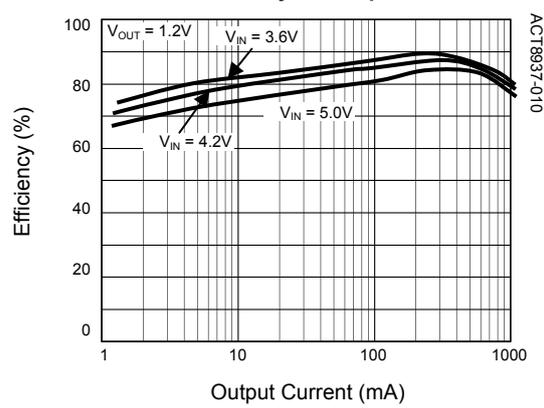


CH1: V_{nPBIN}, 2V/div
CH2: V_{nPBSTAT}, 2V/div
CH3: V_{nRSTO}, 2V/div
TIME: 100ms/div
nPBIN Resistor = 0Ω

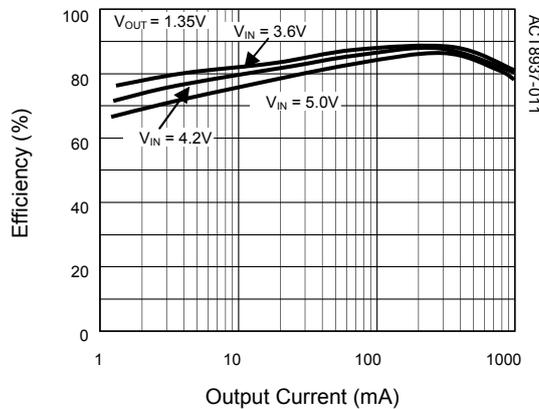
REG1 Efficiency vs. Output Current



REG2 Efficiency vs. Output Current

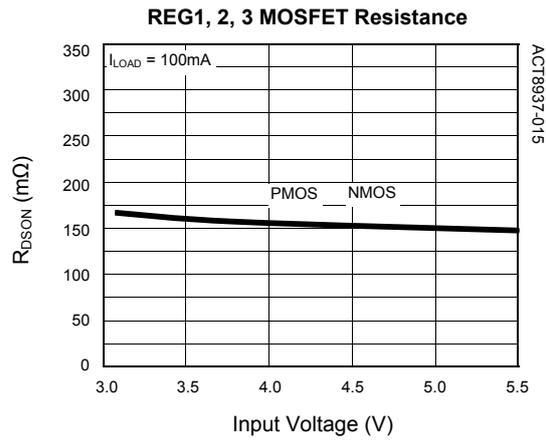
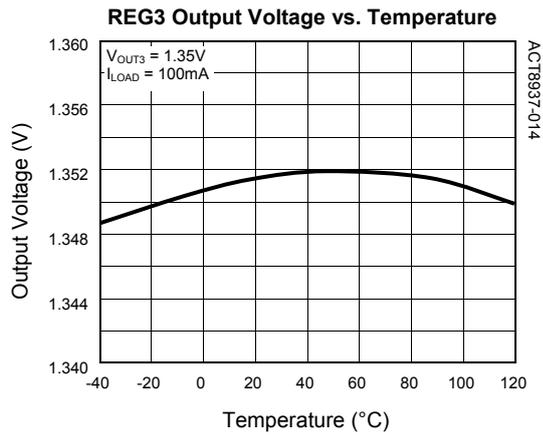
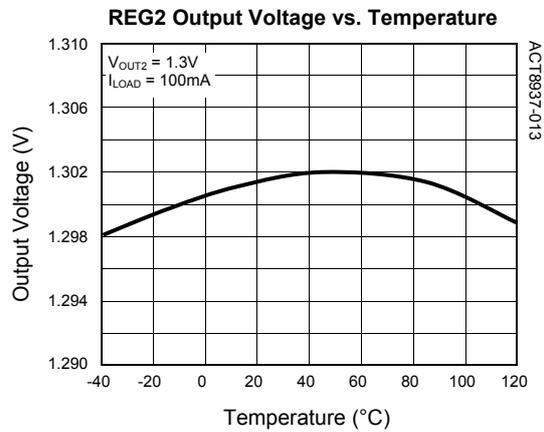
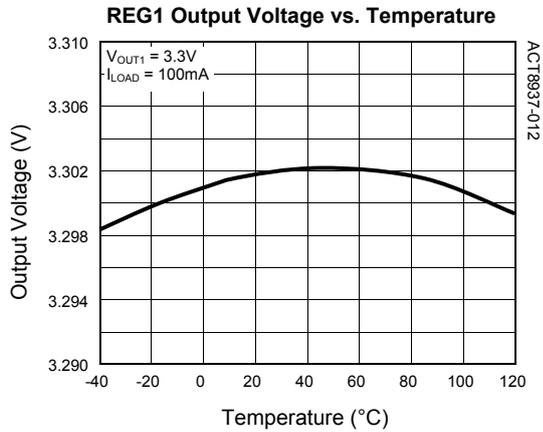


REG3 Efficiency vs. Output Current



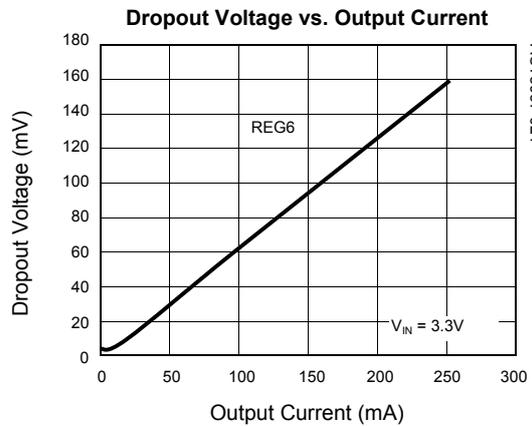
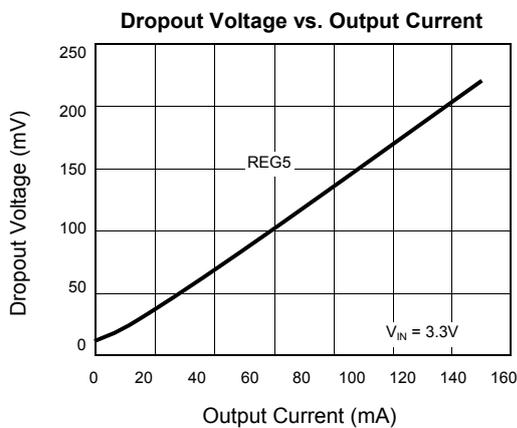
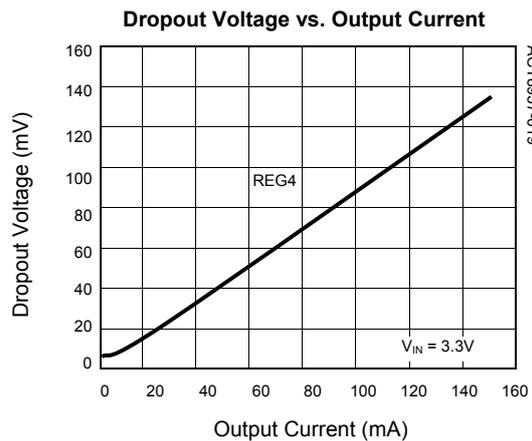
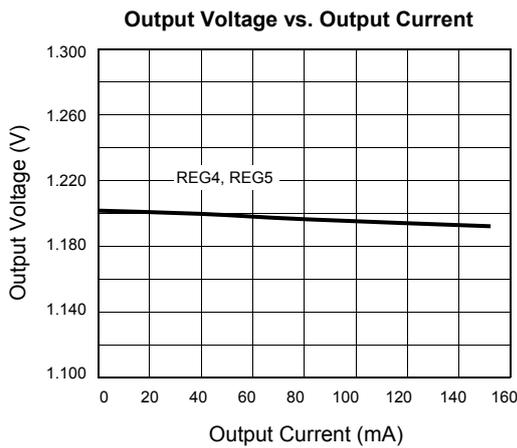
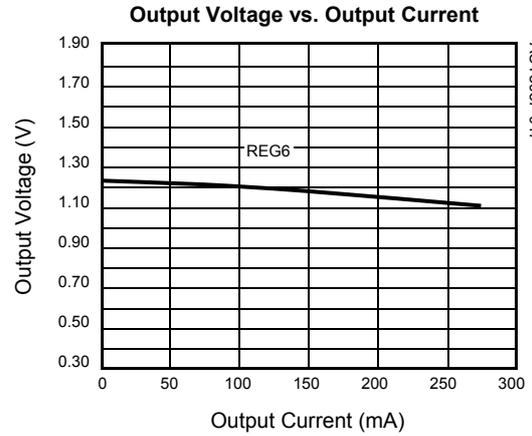
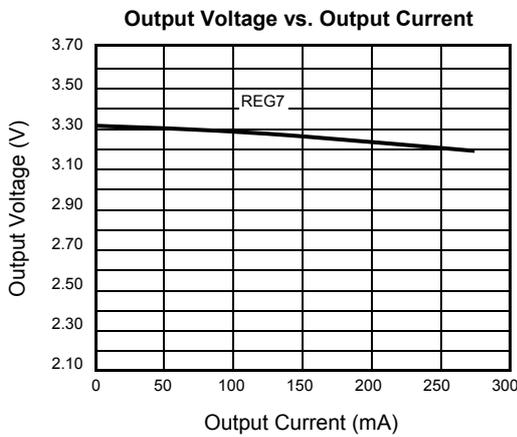
TYPICAL PERFORMANCE CHARACTERISTICS CONT'D

($T_A = 25^\circ\text{C}$, unless otherwise specified.)



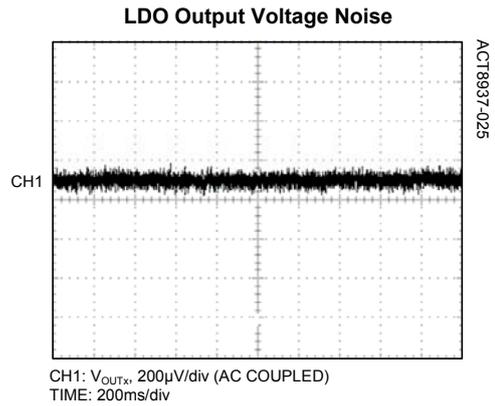
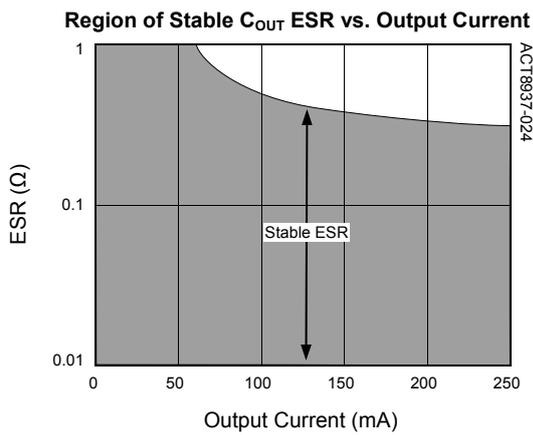
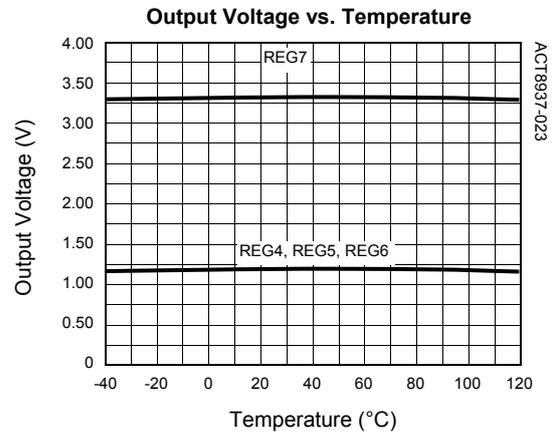
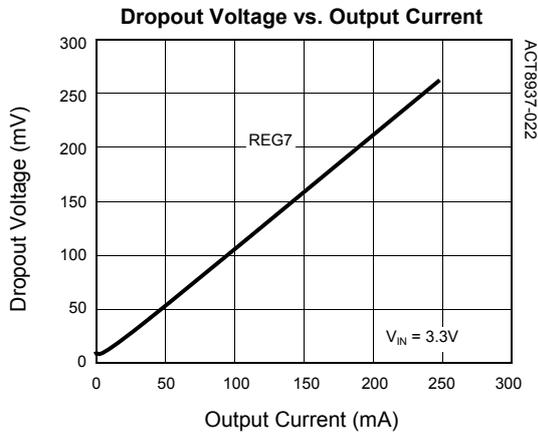
TYPICAL PERFORMANCE CHARACTERISTICS CONT'D

($T_A = 25^\circ\text{C}$, unless otherwise specified.)



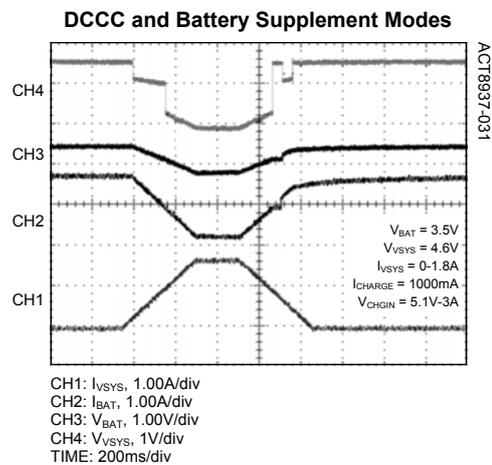
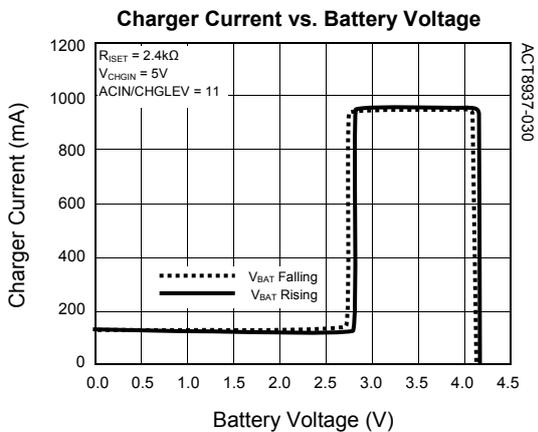
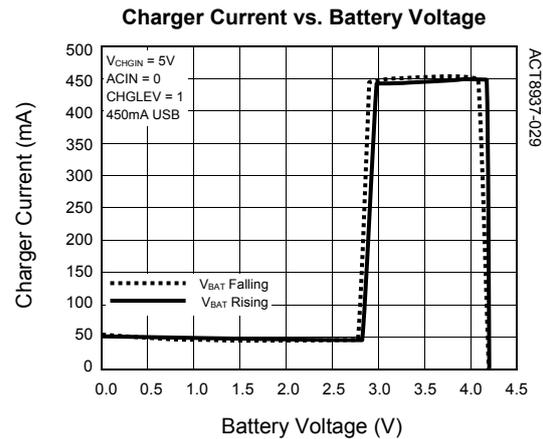
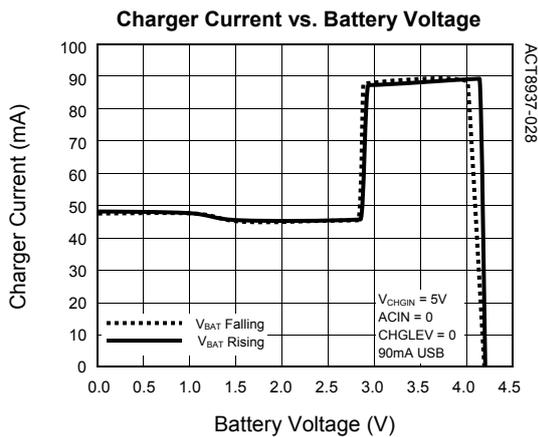
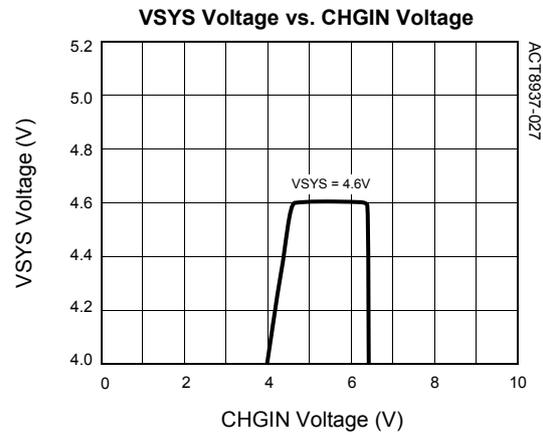
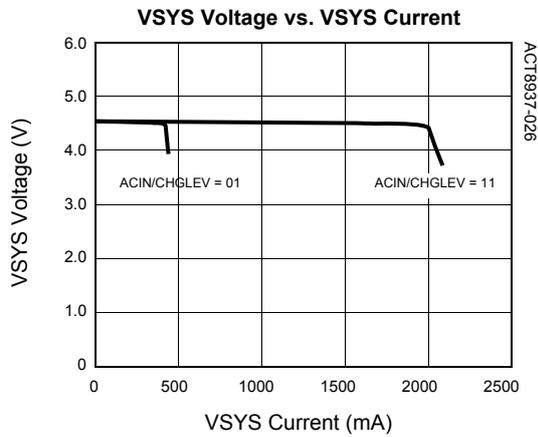
TYPICAL PERFORMANCE CHARACTERISTICS CONT'D

($T_A = 25^\circ\text{C}$, unless otherwise specified.)



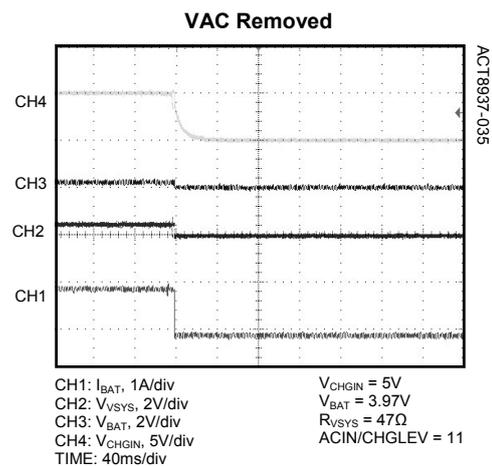
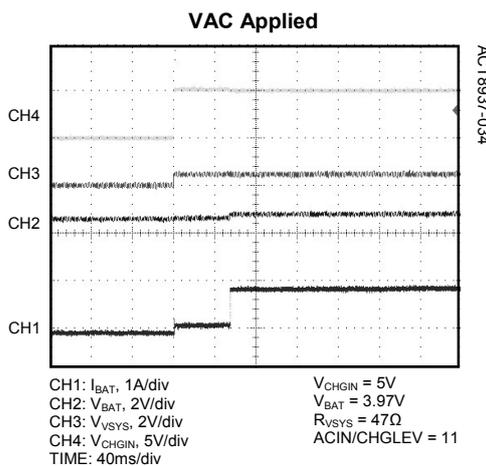
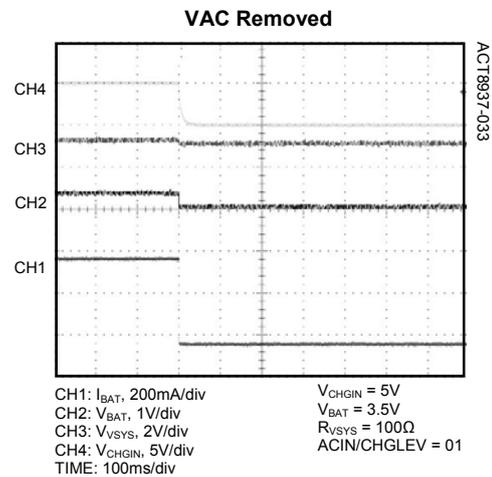
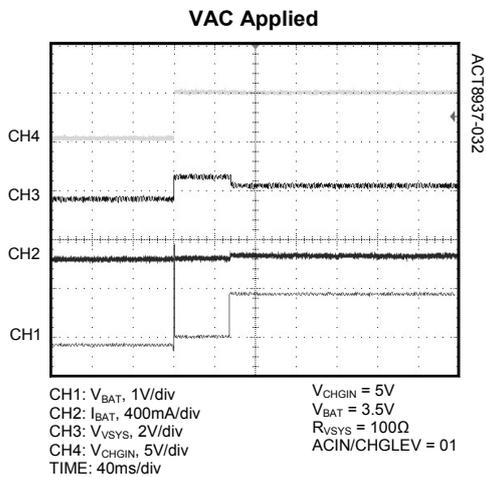
TYPICAL PERFORMANCE CHARACTERISTICS CONT'D

($T_A = 25^\circ\text{C}$, unless otherwise specified.)



TYPICAL PERFORMANCE CHARACTERISTICS CONT'D

($T_A = 25^\circ\text{C}$, unless otherwise specified.)



SYSTEM CONTROL INFORMATION

Interfacing with the Samsung S5PC100, S5PC110 and S5PV210 Processors

The ACT8937 is optimized for use in applications using the S5PC100, S5PC110 and S5PV210 processors, supporting both the power domains as well as the signal interface for these processors.

The following paragraphs describe how to design ACT8937 with S5PV210 Processor, but the design guidelines are directly applicable to S5PC100 and S5PC110 as well.

While the ACT8937 supports many possible configurations for powering these processors, one of the most common configurations is detailed in this datasheet. In general, this document refers to the ACT8937 pin names and functions. However, in cases where the description of interconnections

between these devices benefits by doing so, both the ACT8937 pin names and the Samsung processor pin names are provided. When this is done, the S5PV210 pin names are located after the ACT8937 pin names, and are italicized and located inside parentheses. For example, PWREN (*XPWRRGTON*) refers to the logic signal applied to the ACT8937's PWREN input, identifying that it is driven from the S5PV210's XPWRRGTON output. Likewise, OUT1 (VDD_IO) refers to ACT8937's OUT1 pin, identifying that it is connected to the S5PV210's VDD_IO power domain.

Table 2:

ACT8937 and Samsung S5PV210 Power Domains

| POWER DOMAIN | ACT8937 CHANNEL | TYPE | DEFAULT VOLTAGE | CURRENT CAPABILITY |
|--------------|-----------------|-------|-----------------|--------------------|
| VDD_IO | REG1 | DC/DC | 3.3V | 1100mA |
| VDD_INT | REG2 | DC/DC | 1.1V/1.1V | 1100mA |
| VDD_ARM | REG3 | DC/DC | 1.25V/1.25V | 1200mA |
| VDD_xPLL | REG4 | LDO | 1.1V | 150mA |
| VDD_Alive | REG5 | LDO | 1.1V | 150mA |
| VDD_UOTG_D | REG6 | LDO | 1.1V | 250mA |
| VDD_UOTG_A | REG7 | LDO | 3.3V | 250mA |

Table 3:

ACT8937 and Samsung S5PV210 Power Modes

| POWER MODE | CONTROL STATE | POWER DOMAIN STATE | QUIESCENT CURRENT |
|------------|--|---|-------------------|
| ALL ON | PWRHLD is asserted, PWREN is asserted | REG1, REG2, REG3, REG4, REG5, REG6 and REG7 are all on | 420µA |
| NORMAL | PWRHLD is asserted, PWREN is asserted, REG6 and REG7 are disabled after system boots up. | REG1, REG2, REG3, REG4 and REG5 are on. REG6 and REG7 are off | 340µA |
| SLEEP | PWRHLD is asserted, PWREN is de-asserted, REG6 and REG7 are disabled as default | REG1 and REG5 are on. REG2, REG3, REG4, REG6 and REG7 are off | 190µA |
| ALL OFF | PWRHLD is de-asserted, PWREN is de-asserted | REG1, REG2, REG3, REG4, REG5, REG6 and REG7 are all off | <18µA |

Table 4:
ACT8937 and Samsung S5PV210 Signal Interface

| ACT8937 | DIRECTION | SAMSUNG S5V210 |
|---------|-----------|------------------------------|
| PWREN | ← | XPWRRGTON |
| SCL | ← | Xi2cSCL[0] |
| SDA | ↔ | Xi2cSDA[0] |
| VSEL | ← | DVS_GPIO ^① |
| nRSTO | → | XnRESET |
| nIRQ | → | XEINT0 ^② |
| nPBSTAT | → | XEINT1 ^③ |
| nLBO | → | XnBATF |
| PWRHLD | ← | Power hold GPIO ^④ |

- ①: Optional connection for DVS control.
 ②, ③: Typical connections shown, actual connections may vary.
 ④: Optional connection for power hold control.

Table 5:
Control Pins

| PIN NAME | OUTPUT |
|----------|--|
| nPBIN | REG1, REG2, REG3, REG4, REG5, REG6, REG7 |
| PWRHLD | REG1, REG5 |
| PWREN | REG2, REG3, REG4, REG6, REG7 |

Control Signals

Enable Inputs

The ACT8937 features a variety of control inputs, which are used to enable and disable outputs depending upon the desired mode of operation. PWREN, PWRHLD are logic inputs, while nPBIN is a unique, multi-function input. Refer to Table 5 for a description of which channels are controlled by each input.

nPBIN Multi-Function Input

ACT8937 features the nPBIN multi-function pin, which combines system enable/disable control with a hardware reset function. Select either of the two pin functions by asserting this pin, either through a direct connection to GA, or through a 50kΩ resistor to GA, as shown in Figure 2.

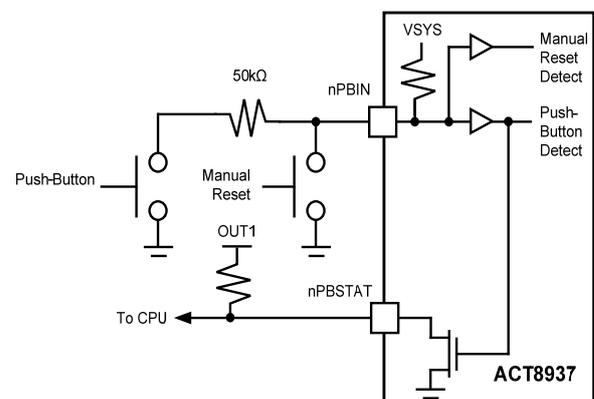
Manual Reset Function

The second major function of the nPBIN input is to provide a manual-reset input for the processor. To manually-reset the processor, drive nPBIN directly to GA through a low impedance (less than 2.5kΩ). When this occurs, nRSTO immediately asserts low, then remains asserted low until the nPBIN input is de-asserted and the reset timeout period expires.

nPBSTAT Output

nPBSTAT is an open-drain output that reflects the state of the nPBIN input; nPBSTAT is asserted low whenever nPBIN is asserted, and is high-Z otherwise. This output is typically used as an interrupt signal to the processor, to initiate a software-programmable routine such as operating mode selection or to open a menu. Connect nPBSTAT to an appropriate supply voltage (typically OUT1) through a 10kΩ or greater resistor.

Figure 2:
nPBIN Input



nRSTO Output

nRSTO is an open-drain output which asserts low upon startup or when manual reset is asserted via the nPBIN input. When asserted on startup, nRSTO remains low until reset timeout period expires after OUT5 reaches its power-OK threshold. When asserted due to manual-reset, nRSTO immediately asserts low, then remains asserted low until the nPBIN input is de-asserted and the reset timeout period expires.

Connect a 10kΩ or greater pull-up resistor from nRSTO to an appropriate voltage supply (typically OUT1).

nIRQ Output

nIRQ is an open-drain output that asserts low any time an interrupt is generated. Connect a 10kΩ or greater pull-up resistor from nIRQ to an appropriate voltage supply. nIRQ is typically used to drive the interrupt input of the system processor.

Many of the ACT8937's functions support interrupt-generation as a result of various conditions. These are typically masked by default, but may be unmasked via the I²C interface. For more information about the available fault conditions, refer to the appropriate sections of this datasheet.

Note that under some conditions a false interrupt may be generated upon initial startup. For this reason, it is recommended that the interrupt service routine check and validate nSYSLEVMSK[] and nFLTMSK[] bits before processing an interrupt generated by these bits. These interrupts may be validated by nSYSSTAT[], OK[] bits.

Push-Button Control

The ACT8937 is designed to initiate a system enable sequence when the nPBIN multi-function input is asserted. Once this occurs, a power-on sequence commences, as described below. The power-on sequence must complete and the microprocessor must take control (by asserting PWREN or PWRHLD) before nPBIN is de-asserted. If the microprocessor is unable to complete its power-up routine successfully before the user lets the push-button go off, the ACT8937 automatically shuts the system down. This provides protection against accidental or momentary assertions of the push-button. If desired, longer "push-and-hold" times can be easily implemented by simply adding an additional time delay before asserting PWREN or PWRHLD.

Control Sequences

The ACT8937 features a variety of control sequences that are optimized for supporting system enable and disable, as well as SLEEP mode of the Samsung S5PC100, S5PC110 and S5PV210 processors.

Enabling/Disabling Sequence

A typical enable sequence is initiated whenever the following conditions occurs:

- 1) nPBIN is asserted low via 50KΩ resistance, or
- 2) A valid input voltage is present at CHGIN[®].

The enable sequence begins by enabling REG5. When REG5 reaches its power-OK threshold, nRSTO is asserted low, resetting the microprocessor. REG2, REG3 and REG4 are enabled after REG5 reaches its power-OK threshold for 8ms^①. When REG2 reaches its power-OK threshold for 8ms^②, REG1 and REG6 are enabled. When REG2 reaches its power-OK threshold for 16ms^②, REG7 is enabled. If REG5 is above its power-OK threshold when the reset timer expires, nRSTO is de-asserted, allowing the microprocessor to begin its boot sequence.

During the boot sequence, the microprocessor must assert PWRHLD, holding REG1 and REG5, and assert PWREN(XPWRRGTON), holding REG2, REG3, REG4, REG6 and REG7 to ensure that the system remains powered after nPBIN is released. REG6 and REG7 can also be enabled/disabled via I²C after microprocessor completes its boot sequence.

Once the power-up routine is completed, the system remains enabled after the push-button is released as long as either PWRHLD or PWREN are asserted high. If the processor does not assert PWRHLD before the user releases the push-button, the boot-up sequence is terminated and all regulators are disabled. This provides protection against "false-enable", when the pushbutton is accidentally depressed, and also ensures that the system remains enabled only if the processor successfully completes the boot-up sequence. To disable REG6 (or REG7) via I²C after the power-up, the software needs to set register bit REG6.ON[] (or REG7.ON[]) to "1" first, then set it back to "0" to turn off the regulator.

As with the enable sequence, a typical disable sequence is initiated when the user presses the push-button, which interrupts the processor via the nPBSTAT output. The actual disable sequence is completely software-controlled, but typically

①: Applicable only for ACT8937QJ2XX.

②: Typical value shown, actual delay time may vary from (T-1ms) x 88% to T x 112%, where T is the typical delay time setting.

involved initiating various “clean-up” processes before the processor finally de-asserts PWRHLD, which disables REG1 and REG5 after push-button is released. Since the processor loses power of VDD_IO and VDD_Alive, it automatically de-asserts PWREN (XPWRRGTON), and hence shuts the system down by disabling REG2, REG3, REG4, REG6 and REG7.

SLEEP Mode Sequence

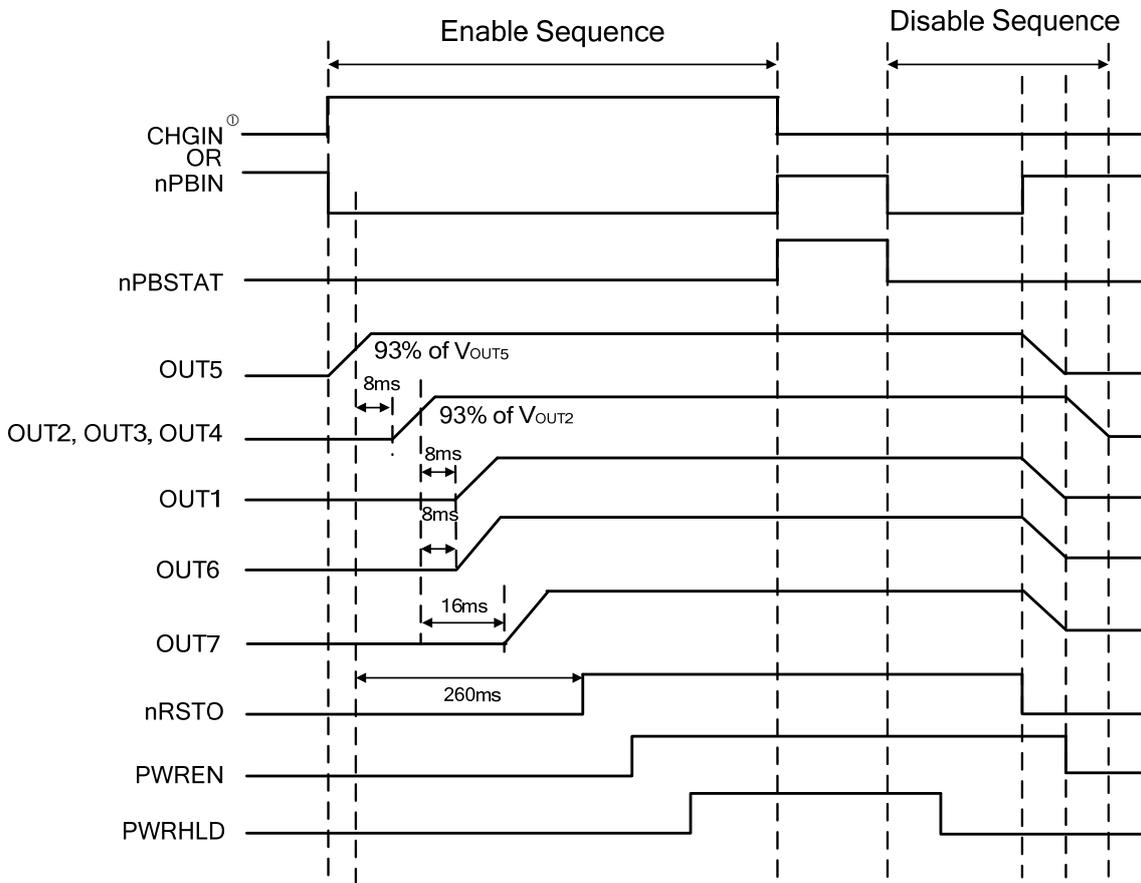
The ACT8937 supports Samsung S5PC100, S5PC110 and S5PV210 processors’ SLEEP mode operation. Once a successful power-up routine has been completed, SLEEP mode may be initiated through a variety of software-controlled mechanisms.

SLEEP mode is typically initiated when the user presses the push-button during normal operation. Pressing the push-button asserts the nPBIN input, which asserts the nPBSTAT output, which interrupts the processor. In response to this

interrupt the processor should de-assert PWREN(XPWRRGTON), disabling REG2, REG3, REG4, REG6 and REG7. PWRHLD should remain asserted during SLEEP mode so that REG1 and REG5 remain enabled.

Waking up from SLEEP mode is typically initiated when the user presses the push-button again, which enables REG2, REG3, REG4, REG6 and REG7 and asserts nPBSTAT. Processors should respond by asserting PWREN(XPWRRGTON), which holds REG2, REG3, REG4, REG6 and REG7 so that normal operation may resume. An external interrupt, for instance a charger interrupt or a RTC interrupt, can also initiate a wake up sequence. When an external interrupt is sent to the processor, the processor should response by getting itself ready to wake up from SLEEP mode first, then assert PWREN(XPWRRGTON), which enables REG2, REG3, REG4, REG6 and REG7 so that the normal operation may resume.

Figure 3:
Enable/Disable Sequence



①: Applicable only for ACT8937QJ2XX.

Figure 4:
Sleep Mode and Wake up Sequence (from Push Button)

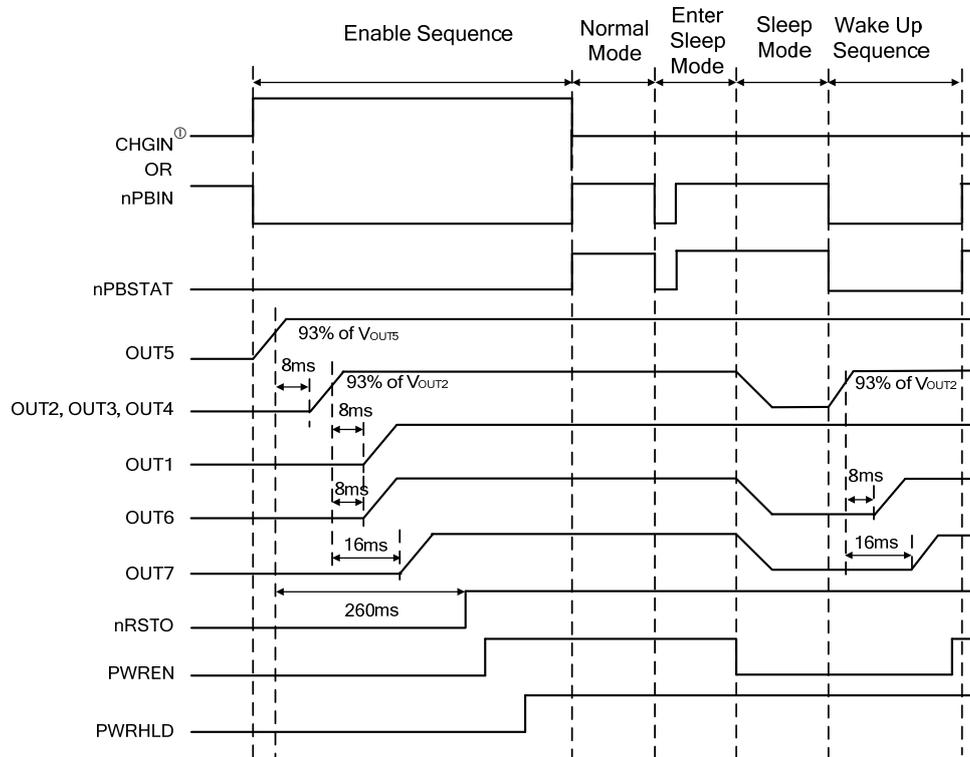
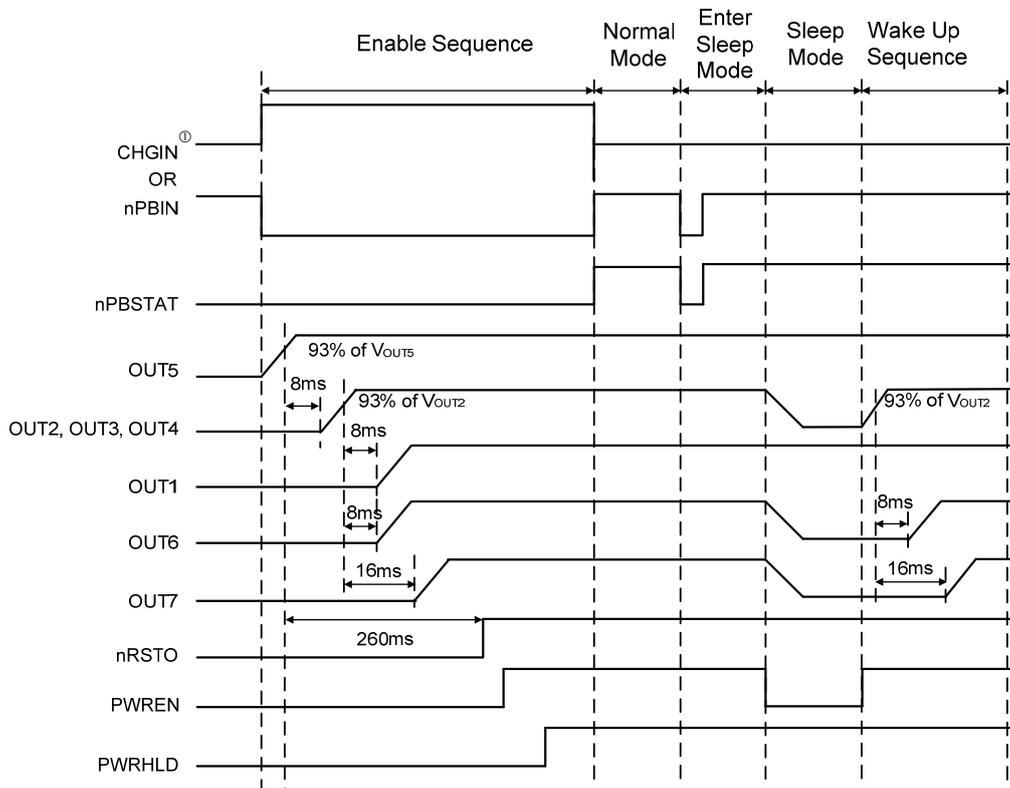


Figure 5:
Sleep Mode and Wake up Sequence (from External Interrupt)



①: Applicable only for ACT8937QJ2XX.

FUNCTIONAL DESCRIPTION

I²C Interface

The ACT8937 features an I²C interface that allows advanced programming capability to enhance overall system performance. To ensure compatibility with a wide range of system processors, the I²C interface supports clock speeds of up to 400kHz (“Fast-Mode” operation) and uses standard I²C commands. I²C write-byte commands are used to program the ACT8937, and I²C read-byte commands are used to read the ACT8937’s internal registers. The ACT8937 always operates as a slave device, and is addressed using a 7-bit slave address followed by an eighth bit, which indicates whether the transaction is a read-operation or a write-operation, [1011011x].

SDA is a bi-directional data line and SCL is a clock input. The master device initiates a transaction by issuing a START condition, defined by SDA transitioning from high to low while SCL is high. Data is transferred in 8-bit packets, beginning with the MSB, and is clocked-in on the rising edge of SCL. Each packet of data is followed by an “Acknowledge” (ACK) bit, used to confirm that the data was transmitted successfully.

For more information regarding the I²C 2-wire serial interface, go to the NXP website: <http://www.nxp.com>.

Housekeeping Functions

Programmable System Voltage Monitor

The ACT8937 features a programmable system-voltage monitor, which monitors the voltage at VSYS and compares it to a programmable threshold voltage. The programmable voltage threshold is programmed by SYSLEV[3:0], as shown in Table 6.

The nSYSSTAT[] bit reflects the output of an internal voltage comparator that monitors VSYS relative to the SYSLEV[] voltage threshold, the value of nSYSSTAT[] = 1 when VSYS is higher than the SYSLEV[] voltage threshold, and nSYSSTAT[] = 0 when VSYS is lower than the SYSLEV[] voltage threshold. Note that the SYSLEV[] voltage threshold is defined for falling voltages, and that the comparator produces about 200mV of hysteresis at VSYS. As a result, once VSYS falls below the SYSLEV threshold, its voltage must increase by more than about 200mV to clear that condition.

The ACT8937 responds in one of two ways when the voltage at VSYS falls below the SYSLEV[] voltage threshold:

1) If nSYSMODE[] = 1 (default case), when VSYS falls below the programmable threshold the ACT8937 asserts nIRQ, providing a software “under-voltage alarm”. The response to this interrupt is

controlled by the CPU, but will typically initiate a controlled shutdown sequence either or alert the user that the battery is low. In this case the interrupt is cleared when nSYSSTAT[] is read via I²C.

2) If nSYSMODE[] = 0, when VSYS falls below the programmable threshold the ACT8937 shuts down, immediately disabling all regulators. This option is useful for implementing a programmable “under-voltage lockout” function that forces the system off when the battery voltage falls below the SYSLEV threshold voltage. Since this option does not support a controlled shutdown sequence, it is generally used as a “fail-safe” to shut the system down when the battery voltage is too low.

Table 6:
SYSLEV Falling Threshold

| SYSLEV[3:0] | SYSLEV Falling Threshold (Hysteresis = 200mV) |
|-------------|--|
| 0000 | 2.3 |
| 0001 | 2.4 |
| 0010 | 2.5 |
| 0011 | 2.6 |
| 0100 | 2.7 |
| 0101 | 2.8 |
| 0110 | 2.9 |
| 0111 | 3.0 |
| 1000 | 3.1 |
| 1001 | 3.2 |
| 1010 | 3.3 |
| 1011 | 3.4 |
| 1100 | 3.5 |
| 1101 | 3.6 |
| 1110 | 3.7 |
| 1111 | 3.8 |

Precision Voltage Detector

The LBI input connects to one input of a precision voltage comparator, which can be used to monitor a system voltage such as the battery voltage. An external resistive-divider network can be used to set voltage monitoring thresholds, as shown in *Functional Block Diagram*. The output of the comparator is present at the nLBO open-drain output.

Thermal Shutdown

The ACT8937 integrates thermal shutdown protection circuitry to prevent damage resulting from excessive thermal stress, as may be encountered under fault conditions. This circuitry disables all regulators if the ACT8937 die temperature exceeds 160°C, and prevents the regulators from being enabled until the IC temperature drops by 20°C (typ).

STEP-DOWN DC/DC REGULATORS

General Description

The ACT8937 features three synchronous, fixed-frequency, current-mode PWM step down converters that achieve peak efficiencies of up to 97%. REG1 and REG2 are capable of supplying up to 1100mA of output current, while REG3 supports up to 1200mA. These regulators operate with a fixed frequency of 2MHz, minimizing noise in sensitive applications and allowing the use of small external components.

100% Duty Cycle Operation

Each regulator is capable of operating at up to 100% duty cycle. During 100% duty-cycle operation, the high-side power MOSFET is held on continuously, providing a direct connection from the input to the output (through the inductor), ensuring the lowest possible dropout voltage in battery powered applications.

Synchronous Rectification

REG1, REG2, and REG3 each feature integrated n-channel synchronous rectifiers, maximizing efficiency and minimizing the total solution size and cost by eliminating the need for external rectifiers.

Soft-Start

When enabled, each output voltages tracks an internal 400 μ s soft-start ramp, minimizing input current during startup and allowing each regulator to power up in a smooth, monotonic manner that is independent of output load conditions.

Compensation

Each buck regulator utilizes current-mode control and a proprietary internal compensation scheme to simultaneously simplify external component selection and optimize transient performance over its full operating range. No compensation design is required; simply follow a few simple guidelines described below when choosing external components.

Input Capacitor Selection

The input capacitor reduces peak currents and noise induced upon the voltage source. A 4.7 μ F ceramic capacitor is recommended for each regulator in most applications.

Output Capacitor Selection

For most applications, 22 μ F ceramic output capacitors are recommended for REG1, REG2 and REG3.

Despite the advantages of ceramic capacitors, care

must be taken during the design process to ensure stable operation over the full operating voltage and temperature range. Ceramic capacitors are available in a variety of dielectrics, each of which exhibits different characteristics that can greatly affect performance over their temperature and voltage ranges.

Two of the most common dielectrics are Y5V and X5R. Whereas Y5V dielectrics are inexpensive and can provide high capacitance in small packages, their capacitance varies greatly over their voltage and temperature ranges and are not recommended for DC/DC applications. X5R and X7R dielectrics are more suitable for output capacitor applications, as their characteristics are more stable over their operating ranges, and are highly recommended.

Inductor Selection

REG1, REG2, and REG3 utilize current-mode control and a proprietary internal compensation scheme to simultaneously simplify external component selection and optimize transient performance over their full operating range. These devices were optimized for operation with 2.2 μ H inductors, although inductors in the 1.5 μ H to 3.3 μ H range can be used. Choose an inductor with a low DC-resistance, and avoid inductor saturation by choosing inductors with DC ratings that exceed the maximum output current by at least 30%.

Configuration Options

Output Voltage Programming

By default, each regulator powers up and regulates to its default output voltage. Output voltage is selectable by setting VSEL pin that when VSEL is low, output voltage is programmed by VSET1[] bits, and when VSEL is high, output voltage is programmed by VSET2[] bits. However, once the system is enabled, each regulator's output voltage may be independently programmed to a different value, typically in order to minimize the power consumption of the microprocessor during some operating modes. Program the output voltages via the I²C serial interface by writing to the regulator's VSET1[] register if VSEL is low or VSET2[] register if VSEL is high as shown in Table 8.

Enable / Disable Control

During normal operation, each buck may be enabled or disabled via the I²C interface by writing to that regulator's ON[] bit. To enable the regulator set ON[] to 1, to disable the regulator clear ON[] to 0.

REG1, REG2, REG3 Turn-on Delay

Each of REG1, REG2 and REG3 features a programmable Turn-on Delay which help ensure a reliable qualification. This delay is programmed by DELAY[2:0], as shown in Table 7.

Table 7:

REGx/DELAY[] Turn-On Delay

| DELAY[2] | DELAY[1] | DELAY[0] | TURN-ON DELAY |
|----------|----------|----------|---------------|
| 0 | 0 | 0 | 0 ms |
| 0 | 0 | 1 | 2 ms |
| 0 | 1 | 0 | 4 ms |
| 0 | 1 | 1 | 8 ms |
| 1 | 0 | 0 | 16 ms |
| 1 | 0 | 1 | 32 ms |
| 1 | 1 | 0 | 64 ms |
| 1 | 1 | 1 | 128 ms |

Operating Mode

By default, REG1, REG2, and REG3 each operate in fixed-frequency PWM mode at medium to heavy loads, while automatically transitioning to a proprietary power-saving mode at light loads in order to maximize standby battery life. In applications where low noise is critical, force fixed-frequency PWM operation across the entire load current range, at the expense of light-load efficiency, by setting the MODE[] bit to 1.

OK[] and Output Fault Interrupt

Each DC/DC features a power-OK status bit that can be read by the system microprocessor via the I²C

interface. If an output voltage is lower than the power-OK threshold, typically 7% below the programmed regulation voltage, that regulator's OK[] bit will be 0.

If a DC/DC's nFLTMSK[] bit is set to 1, the ACT8937 will interrupt the processor if that DC/DC's output voltage falls below the power-OK threshold. In this case, nIRQ will assert low and remain asserted until the OK[] bit has been read via I²C.

PCB Layout Considerations

High switching frequencies and large peak currents make PC board layout an important part of step-down DC/DC converter design. A good design minimizes excessive EMI on the feedback paths and voltage gradients in the ground plane, both of which can result in instability or regulation errors.

Step-down DC/DCs exhibit discontinuous input current, so the input capacitors should be placed as close as possible to the IC, and avoiding the use of via if possible. The inductor, input filter capacitor, and output filter capacitor should be connected as close together as possible, with short, direct, and wide traces. The ground nodes for each regulator's power loop should be connected at a single point in a star-ground configuration, and this point should be connected to the backside ground plane with multiple via. The output node for each regulator should be connected to its corresponding OUTx pin through the shortest possible route, while keeping sufficient distance from switching nodes to prevent noise injection. Finally, the exposed pad should be directly connected to the backside ground plane using multiple via to achieve low electrical and thermal resistance.

Table 8:

REGx/VSET[] Output Voltage Setting

| REGx/VSET[2:0] | REGx/VSET[5:3] | | | | | | | |
|----------------|----------------|-------|-------|-------|-------|-------|-------|-------|
| | 000 | 001 | 010 | 011 | 100 | 101 | 110 | 111 |
| 000 | 0.600 | 0.800 | 1.000 | 1.200 | 1.600 | 2.000 | 2.400 | 3.200 |
| 001 | 0.625 | 0.825 | 1.025 | 1.250 | 1.650 | 2.050 | 2.500 | 3.300 |
| 010 | 0.650 | 0.850 | 1.050 | 1.300 | 1.700 | 2.100 | 2.600 | 3.400 |
| 011 | 0.675 | 0.875 | 1.075 | 1.350 | 1.750 | 2.150 | 2.700 | 3.500 |
| 100 | 0.700 | 0.900 | 1.100 | 1.400 | 1.800 | 2.200 | 2.800 | 3.600 |
| 101 | 0.725 | 0.925 | 1.125 | 1.450 | 1.850 | 2.250 | 2.900 | 3.700 |
| 110 | 0.750 | 0.950 | 1.150 | 1.500 | 1.900 | 2.300 | 3.000 | 3.800 |
| 111 | 0.775 | 0.975 | 1.175 | 1.550 | 1.950 | 2.350 | 3.100 | 3.900 |

LOW-NOISE, LOW-DROPOUT LINEAR REGULATORS

General Description

REG4, REG5, REG6, and REG7 are low-noise, low-dropout linear regulators (LDOs) that supply up to 150mA, 150mA, 250mA, and 250mA, respectively. Each LDO has been optimized to achieve low noise and high-PSRR, achieving more than 65dB PSRR at frequencies up to 10kHz.

Output Current Limit

Each LDO contains current-limit circuitry featuring a current-limit fold-back function. During normal and moderate overload conditions, the regulators can support more than their rated output currents. During extreme overload conditions, however, the current limit is reduced by approximately 30%, reducing power dissipation within the IC.

Compensation

The LDOs are internally compensated and require very little design effort, simply select input and output capacitors according to the guidelines below.

Input Capacitor Selection

Each LDO requires a small ceramic input capacitor to supply current to support fast transients at the input of the LDO. Bypassing each INL pin to GA with 1 μ F. High quality ceramic capacitors such as X7R and X5R dielectric types are strongly recommended.

Output Capacitor Selection

Each LDO requires a small ceramic output capacitor for stability. Capacitance value is 1.5 μ F for REG4 and REG5, 2.2 μ F for REG6 and REG7. For best performance, each output capacitor should be connected directly between the output and GA pins, as close to the output as possible, and with a short, direct connection. High quality ceramic capacitors such as X7R and X5R dielectric types are strongly recommended.

Configuration Options

Output Voltage Programming

By default, each LDO powers up and regulates to its default output voltage. Once the system is enabled, each output voltage may be independently programmed to a different value by writing to the regulator's VSET[] register via the I²C serial interface as shown in Table 8.

Enable / Disable Control

During normal operation, each LDO may be enabled or disabled via the I²C interface by writing

to that LDO's ON[] bit. To enable the LDO set ON[] to 1, to disable the LDO clear ON[] to 0.

REG4, REG5, REG6, REG7 Turn-on Delay

Each of REG4, REG5, REG6 and REG7 features a programmable Turn-on Delay which help ensure a reliable qualification. This delay is programmed by DELAY[2:0], as shown in Table 7.

Output Discharge

Each of the ACT8937's LDOs features an optional output discharge function, which discharges the output to ground through a 1.5k Ω resistance when the LDO is disabled. This feature may be enabled or disabled by setting DIS[] via; set DIS[] to 1 to enable this function, clear DIS[] to 0 to disable it.

Low-Power Mode

Each of ACT8937's LDOs features a LOWIQ[] bit which, when set to 1, reduces the LDO's quiescent current by about 16%, saving power and extending battery lifetime.

OK[] and Output Fault Interrupt

Each LDO features a power-OK status bit that can be read by the system microprocessor via the interface. If an output voltage is lower than the power-OK threshold, typically 11% below the programmed regulation voltage, the value of that regulator's OK[] bit will be 0.

If a LDO's nFLTMSK[] bit is set to 1, the ACT8937 will interrupt the processor if that LDO's output voltage falls below the power-OK threshold. In this case, nIRQ will assert low and remain asserted until the OK[] bit has been read via I²C.

PCB Layout Considerations

PCB Layout Considerations The ACT8937's LDOs provide good DC, AC, and noise performance over a wide range of operating conditions, and are relatively insensitive to layout considerations. When designing a PCB, however, careful layout is necessary to prevent other circuitry from degrading LDO performance.

A good design places input and output capacitors as close to the LDO inputs and output as possible, and utilizes a star-ground configuration for all regulators to prevent noise-coupling through ground. Output traces should be routed to avoid close proximity to noisy nodes, particularly the SW nodes of the DC/DCs.

REFBP is a filtered reference noise, and internally

has a direct connection to the linear regulator controller. Any noise injected onto REFBP will directly affect the outputs of the linear regulators, and therefore special care should be taken to ensure that no noise is injected to the outputs via REFBP. As with the LDO output capacitors, the REFBP bypass capacitor should be placed as close to the IC as possible, with short, direct connections to the star-ground. Avoid the use of via whenever possible. Noisy nodes, such as from the DC/DCs, should be routed as far away from REFBP as possible.

ActivePath™ CHARGER

General Description

The ACT8937 features an advanced battery charger that incorporates the patent-pending *ActivePath architecture for system power selection*. This combination of circuits provides a complete, advanced battery-management system that automatically selects the best available input supply, manages charge current to ensure system power availability, and provides a complete, high-accuracy ($\pm 0.5\%$), thermally regulated, full-featured single-cell linear Li+ charger that can withstand input voltages of up to 12V.

ActivePath Architecture

The *ActivePath* architecture performs three important functions:

- 1) System Configuration Optimization
- 2) Input Protection
- 3) Battery-Management

System Configuration Optimization

The *ActivePath* circuitry monitors the state of the input supply, the battery, and the system, and automatically reconfigures itself to optimize the power system. If a valid input supply is present, *ActivePath* powers the system from the input while charging the battery in parallel. This allows the battery to charge as quickly as possible, while supplying the system. If a valid input supply is not present, *ActivePath* powers the system from the battery. Finally, if the input is present and the system current requirement exceeds the capability of the input supply, *ActivePath* allows system power to be drawn from both the battery and the input supply.

Input Protection

Input Over-Voltage Protection

The *ActivePath* circuitry features input over-voltage protection circuitry. This circuitry disables charging when the input voltage exceeds the voltage set by OVPSET[] as shown in Table 9, but stands off the input voltage in order to protect the system. Note that the adjustable OVP threshold is intended to provide the charge cycle with adjustable immunity against upward voltage transients on the input, and is not intended to allow continuous charging with input voltages above the charger's normal operating voltage range. Independent of the OVPSET[] setting, the charge cycle is not allowed to continue until the input voltage falls back into the charger's normal operating voltage range (i.e. below 6.0V).

In an input over-voltage condition this circuit limits VSYS to 4.6V, protecting any circuitry connected to VSYS from the over-voltage condition, which may exceed this circuitry's voltage capability. This circuit is capable of withstanding input voltages of up to 12V.

Table 9:

Input Over-Voltage Protection Setting

| OVPSET[1] | OVPSET[0] | OVP THRESHOLD |
|-----------|-----------|---------------|
| 0 | 0 | 6.6V |
| 0 | 1 | 7.0V |
| 1 | 0 | 7.5V |
| 1 | 1 | 8.0V |

Input Supply Overload Protection

The *ActivePath* circuitry monitors and limits the total current drawn from the input supply to a value set by the ACIN and CHGLEV inputs, as well as the resistor connected to ISET. Drive ACIN to a logic-low for "USB Mode", which limits the current to either 100mA, when CHGLEV is driven to a logic-low, or 500mA, when CHGLEV is driven to a logic-high. Drive ACIN to a logic-high for "AC-Mode", which limits the input current to 2A, typically.

Input Under Voltage Lockout

If the input voltage applied to CHGIN falls below 3.5V (typ), an input under-voltage condition is detected and the charger is disabled. Once an input under-voltage condition is detected, a new charge cycle will initiate when the input exceeds the under-voltage threshold by at least 500mV.

Battery Management

The ACT8937 features a full-featured, intelligent charger for Lithium-based cells, and was designed specifically to provide a complete charging solution with minimum system design effort.

The core of the charger is a CC/CV (Constant-Current/Constant-Voltage), linear-mode charge controller. This controller incorporates current and voltage sense circuitry, an internal 70mΩ power MOSFET, thermal-regulation circuitry, a full-featured state-machine that implements charge control and safety features, and circuitry that eliminates the reverse blocking diode required by conventional charger designs.

The charge termination voltage is highly accurate ($\pm 0.5\%$), and features a selection of charge safety timeout periods that protect the system from operation with damaged cells. Other features

include pin-programmable fast-charge current and one current-limited nSTAT output that can directly drive LED indicator or provide a logic-level status signal to the host microprocessor.

Dynamic Charge Current Control (DCCC)

The ACT8937's *ActivePath* charger features dynamic charge current control (DCCC) circuitry, which acts to ensure that the system remains powered while operating within the maximum output capability of the power adapter. The DCCC circuitry continuously monitors VSYS, and if the voltage at VSYS drops by more than 200mV, the DCCC circuitry automatically reduces charge current in order to prevent VSYS from continuing to drop.

Charge Current Programming

The ACT8937's *ActivePath* charger features a flexible charge current-programming scheme that combines the convenience of internal charge current programming with the flexibility of resistor based charge current programming. Current limits and charge current programming are managed as a function of the ACIN and CHGLEV pins, in combination with R_{ISSET}, the resistance connected to the ISET pin.

ACIN is a logic input that configures the current-limit of *ActivePath*'s linear regulator as well as that of the battery charger. ACIN features a precise 1.2V logic threshold, so that the input voltage detection threshold may be adjusted with a simple resistive voltage divider. This input also allows a simple, low-cost dual-input charger switch to be implemented with just a few, low-cost components.

When the voltage at ACIN is above the 1.2V threshold, the charger operates in "AC-Mode" with a charge current programmed by R_{ISSET}, and the R_{ISSET} is given by:

$$R_{ISSET} \text{ (k}\Omega\text{)} = 2336 \times (1V/I_{CHG} \text{ (mA)}) - 0.205$$

With a given R_{ISSET} then charge current will reduce 5 times when CHGLEV is driven low.

When ACIN is below the 1.2V threshold, the charger operates in "USB-Mode", with a maximum

charge current defined by the CHGLEV input; 500mA, if CHGLEV is driven to a logic-high, or 100mA, if CHGLEV is driven to a logic-low.

The ACT8937's charge current settings are summarized in Table 10.

Note that the actual charge current may be limited to a current lower than the programmed fast charge current due to the ACT8937's internal thermal regulation loop. See the *Thermal Regulation* section for more information.

In order to ease input supply detection and eliminate the size and cost of external detection circuitry, the charger has the ability to generate interrupts based upon the status of the input supply. This function is capable of generating an interrupt when the input is connected, disconnected, or both. An interrupt is generated any time the input supply is connected when INSTAT[] bit is set to 1 and the INCON[] bit is set to 1, and an interrupt is generated any time the input supply is disconnected when INSTAT[] bit is set to 1 and the INDIS[] bit is set to 1.

The status of the input may be read at any time by reading the INDAT[] bit, where a value of 1 indicates that the valid input ($V_{CHGIN} > V_{UVLO} < V_{CHGIN} < V_{OVP}$) is present, and a value of 0 indicates that a valid input is not present. Reading the INSTAT[] bit indicates when the input has generated an interrupt; this bit will normally return a value of 0, but will return value of 1 when an input interrupt has been generated then the interrupt is automatically cleared to 0 upon reading.

When responding to an Input Status Interrupt, it is often useful to know the state of the ACIN input. For example, in a dual-input charger application knowing the state of the ACIN input can identify which type of input supply has been connected. The state of the ACIN input can be read at any time by reading the ACINSTAT[] bit, where a value of 1 indicates that the voltage at ACIN is above the 1.2V threshold (indicating that a wall-cube has been attached), and a value of 0 indicates that the voltage is below this threshold (indicating that ACIN input is not valid and USB supply input is selected).

Table 10:

ACIN and CHGLEV Inputs

| ACIN | CHGLEV | CHARGE CURRENT (mA) | PRECONDITION CHARGE CURRENT (mA) |
|------|--------|---------------------|----------------------------------|
| 0 | 0 | 90mA | 45mA |
| 0 | 1 | 450mA | 45mA |
| 1 | 0 | I _{CHG} /5 | 10% × I _{CHG} |
| 1 | 1 | I _{CHG} | 10% × I _{CHG} |

Figure 6:
Typical Li+ charge profile and ACT8937 charge states

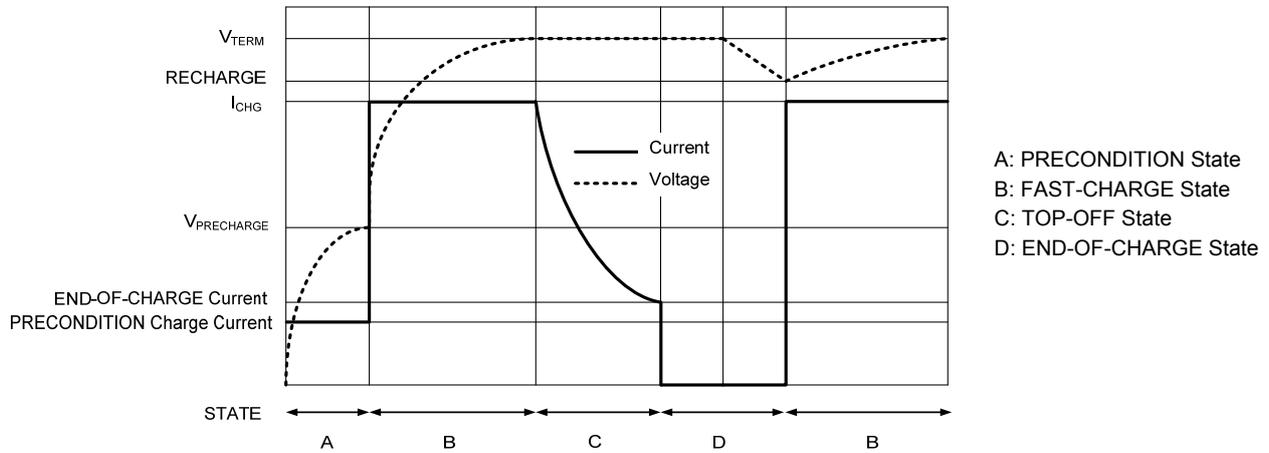
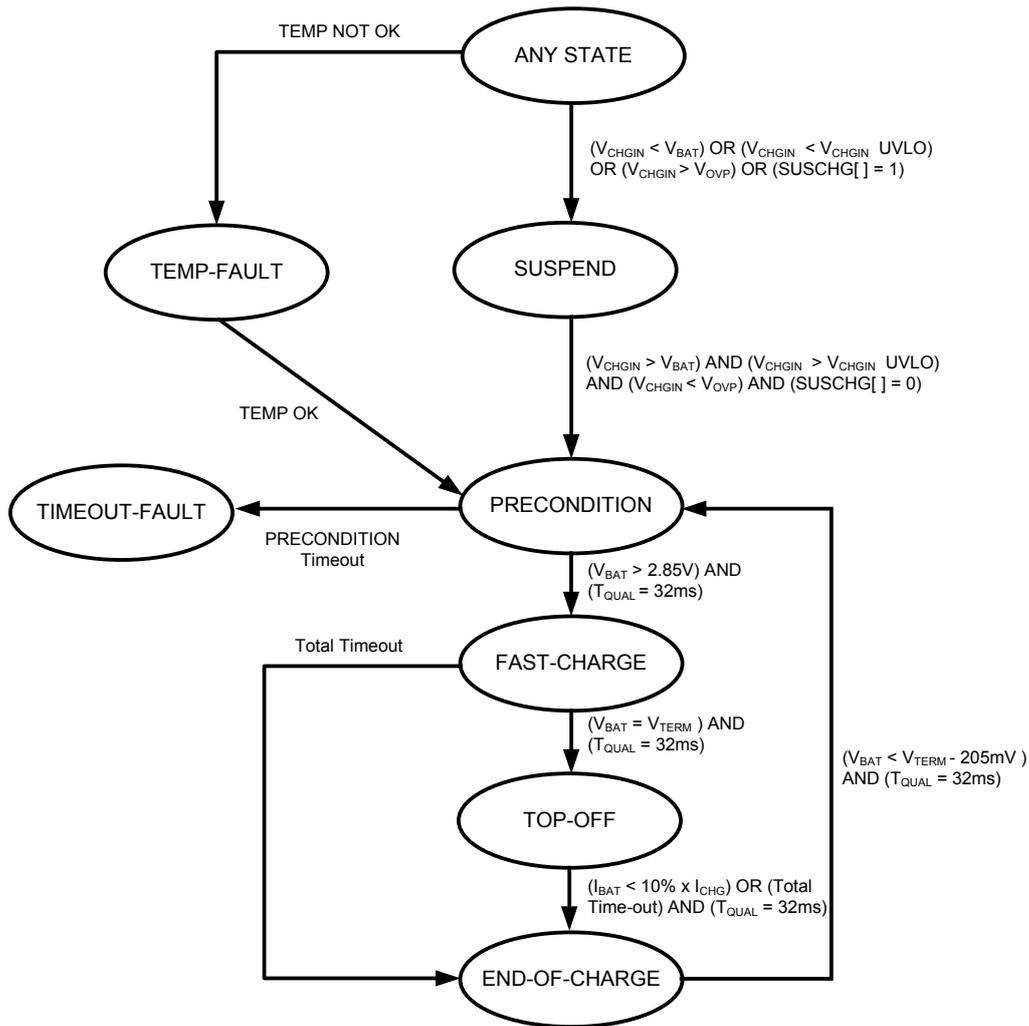


Figure 7:
Charger State Diagram



Charge-Control State Machine

PRECONDITION State

A new charging cycle begins with the PRECONDITION state, and operation continues in this state until V_{BAT} exceeds the Precondition Threshold Voltage. When operating in PRECONDITION state, the cell is charged at 10% of the programmed maximum fast-charge constant current, I_{CHG} [].

Once V_{BAT} reaches the Precondition Threshold Voltage, the state machine jumps to the FAST-CHARGE state. If V_{BAT} does not reach the Precondition Threshold Voltage before the Precondition Timeout period expires, then the state machine jumps to the TIMEOUT-FAULT state in order to prevent charging a damaged cell. See the *Charge Safety Timers* section for more information.

FAST-CHARGE State

In the FAST-CHARGE state, the charger operates in constant-current (CC) mode and regulates the charge current to the current set by R_{ISET} . Charging continues in CC mode until V_{BAT} reaches the charge termination voltage (V_{TERM}), at which point the state-machine jumps to the TOP-OFF state. If V_{BAT} does not reach V_{TERM} before the total time out period expires then the state-machine will jump to the “EOC” state and will re-initiate a new charge cycle after 32ms “relax”. See the *Current Limits* and *Charge Current Programming* sections for more information about setting the maximum charge current.

TOP-OFF State

In the TOP-OFF state, the cell charges in constant-voltage (CV) mode. In CV mode operation, the charger regulates its output voltage to the 4.20V charge termination voltage, and the charge current is naturally reduced as the cell approaches full charge. Charging continues until the charge current drops to END-OF-CHARGE current threshold, at which point the state machine jumps to the END-OF-CHARGE (EOC) state.

If the state-machine does not jump out of the TOP-OFF state before the Total-Charge Timeout period expires, the state machine jumps to the EOC state and will re-initiate a new charge cycle if V_{BAT} falls below termination voltage 205mV (typ). For more information about the charge safety timers, see the *Charging Safety Times* section.

END-OF-CHARGE (EOC) State

In the END-OF-CHARGE (EOC) state, the charger

presents a high-impedance to the battery, minimizing battery current drain and allowing the cell to “relax”. The charger continues to monitor the cell voltage, and re-initiates a charging sequence if the cell voltage drops to 205mV (typ) below the charge termination voltage.

SUSPEND State

The state-machine jumps to the SUSPEND state any time the battery is removed, and any time the input voltage falls below either the UVLO threshold or exceeds the OVP threshold. Once none of these conditions are present, a new charge cycle initiates.

A charging cycle may also be suspended manually by setting the SUSPEND[] bit. In this case, initiate a new charging sequence by clearing SUSPEND[] to 0.

State Machine Interrupts

The charger features the ability to generate interrupts when the charger state machine transitions, based upon the status of the CHG_ bits. An interrupt may be generated when the state machine transitions to END-OF-CHARGE (EOC) state by setting the CHGEOCIN[] bit to 1 and CHGSTAT[] bit to 1. An interrupt may be generated when machine transitions get out END-OF-CHARGE (EOC) state by setting the CHGEOCOUT[] bit to 1 and CHGSTAT[] bit to 1.

The status of the charge state machine may be read at any time by reading the CHGDAT[] bit, where a value of 0 indicates no interrupt generated, and a value of 1 indicates interrupt generated. Reading the CHGSTAT[] bit indicates when a state machine transition has generated an interrupt; this bit will normally return a value of 0, but will return value of 1 when a state transition occurs then the interrupt is automatically cleared to 0 upon reading.

For additional information about the charge cycle, CSTATE[1:0] may be read at any time via I²C to determine the current charging state.

Table 11:
Charging Status Indication

| CSTATE[1] | CSTATE[0] | STATE MACHINE STATUS |
|-----------|-----------|----------------------|
| 0 | 0 | PRECONDITION State |
| 0 | 1 | FAST-CHARGE State |
| 1 | 0 | TOP-OFF State |
| 1 | 1 | END-OF-CHARGE State |

Thermal Regulation

The charger features an internal thermal regulation loop that monitors die temperature and reduces charging current as needed to ensure that the die temperature does not exceed the thermal regulation threshold of 110°C. This feature protects against excessive junction temperature and makes the device more accommodating to aggressive thermal designs. Note, however, that attention to good thermal designs is required to achieve the fastest possible charge time by maximizing charge current.

Charge Safety Timers

The charger features programmable charge safety timers which help ensure a safe charge by detecting potentially damaged cells. These timers are programmable via the PRETIMO[1:0] and TOTTIMO[1:0] bits, as shown in Table 12 and Table 13. Note that in order to account for reduced charge current resulting from DCCC operation, the charge timeout periods are extended proportionally to the reduction in charge current. As a result, the actual safety period may exceed the nominal timer period.

The charger features the ability to generate interrupts based upon the status of the charge timers, based upon the status of the TIMR_ bits. Generate interrupts when the Precondition Timer expires by setting the TIMRPRE[] bit to 1 and TIMRSTAT[] bit to 1, generate interrupts when the Total-Charge Timer expires by setting the TIMRTOT[] bit to 1 and TIMRSTAT[] bit to 1.

The status of the charge timers may be read at any time by reading the TIMRDAT[] bit, where a value of 0 indicates that neither charge timer has expired, and a value of 1 indicates that one of the charge timers has expired. Reading the TIMRSTAT[] bit indicates when a charge timer has generated an interrupt; this bit will normally return a value of 0, but will return value of 1 when a charge-timer interrupt has been generated then the interrupt is automatically cleared to 0 upon reading.

Table 12:
PRECONDITION Safety Timer Setting

| PRETIMO[1] | PRETIMO[0] | PRECONDITION TIMEOUT PERIOD |
|------------|------------|-----------------------------|
| 0 | 0 | 40 mins |
| 0 | 1 | 60 mins |
| 1 | 0 | 80 mins |
| 1 | 1 | Disabled |

Table 13:
Total Safety Timer Setting

| TOTTIMO[1] | TOTTIMO[0] | TOTAL TIMEOUT PERIOD |
|------------|------------|----------------------|
| 0 | 0 | 3 hrs |
| 0 | 1 | 4 hrs |
| 1 | 0 | 5 hrs |
| 1 | 1 | Disabled |

Charge Status Indicator

The charger provides a charge-status indicator output, nSTAT. nSTAT is an open-drain output which sinks current when the charger is in an active-charging state, and is high-Z otherwise. nSTAT features an internal 8mA current limit, and is capable of directly driving a LED without the need of a current-limiting resistor or other external circuitry. To drive an LED, simply connect the LED between nSTAT pin and an appropriate supply, such as VSYS. For a logic-level charge status indication, simply connect a resistor from nSTAT to an appropriate voltage supply.

Table 14:
Charging Status Indication

| STATE | nSTAT |
|-------------------|--------|
| PRECONDITION | Active |
| FAST-CHARGE | Active |
| TOP-OFF | Active |
| END-OF-CHARGE | High-Z |
| SUSPEND | High-Z |
| TEMPERATURE FAULT | High-Z |
| TIMEOUT-FAULT | High-Z |

Reverse-Current Protection

The charger includes internal reverse-current protection circuitry that eliminates the need for blocking diodes, reducing solution size and cost as well as dropout voltage relative to conventional battery chargers. When the voltage at CHGIN falls below V_{BAT}, the charger automatically reconfigures its power switch to minimize current drawn from the battery.

Battery Temperature Monitoring

In a typical application, the TH pin is connected to the battery pack's thermistor input, as shown in

Figure 8. The charger continuously monitors the temperature of the battery pack by injecting a 102µA (typ) current into the thermistor (via the TH pin) and sensing the voltage at TH. The voltage at TH is continuously monitored, and charging is suspended if the voltage at TH exceeds either of the internal V_{THH} and V_{THL} thresholds of 0.5V and 2.51V, respectively.

The net resistance (from TH to GA) required to cross the thresholds are given by:

$$102\mu\text{A} \times R_{\text{NOM}} \times k_{\text{HOT}} = 0.5\text{V} \rightarrow R_{\text{NOM}} \times k_{\text{HOT}} \approx 5\text{k}\Omega$$

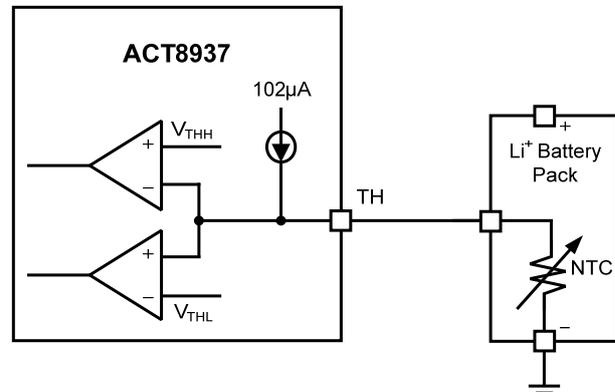
$$102\mu\text{A} \times R_{\text{NOM}} \times k_{\text{COLD}} = 2.51\text{V} \rightarrow R_{\text{NOM}} \times k_{\text{COLD}} \approx 25\text{k}\Omega$$

where R_{NOM} is the nominal thermistor resistance at room temperature, and k_{HOT} and k_{COLD} represent the ratios of the thermistor's resistance at the desired hot and cold thresholds, respectively, to the resistance at 25°C.

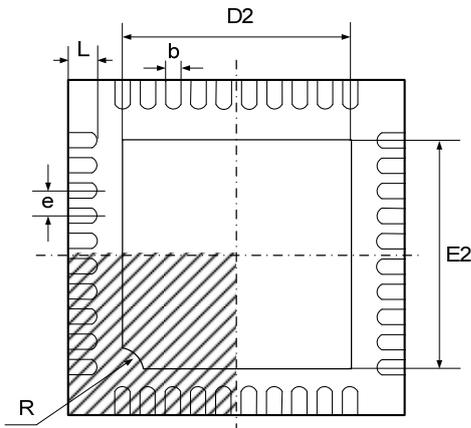
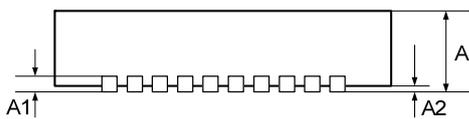
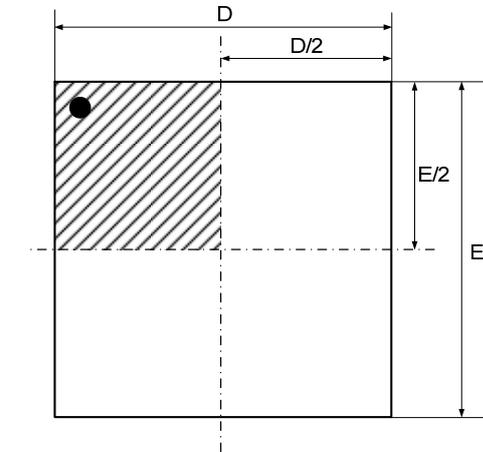
In order to ease detecting the status of the battery temperature, the charger features the ability to generate interrupts based upon the status of the battery temperature. Generate an interrupt when battery temperature goes out of the valid temperature range by setting the TEMPOUT[] bit to 1 and TEMPSTAT[] bit to 1. Generated an interrupt when battery temperature returns to the valid range by setting the TEMPIN[] bit to 1 and TEMPSTAT[] bit to 1.

The status of the battery temperature may be read at any time by reading the TEMPDAT[] bit, where a value of 1 indicates that battery temperature is within the valid range, and a value of 0 indicates that battery temperature has exceeded either of the thresholds. Reading the TEMPSTAT[] bit indicates when the battery temperature has generated an interrupt; this bit will normally return a value of 0, but will return value of 1 when a cell-temperature interrupt has been generated then the interrupt is automatically cleared to 0 upon reading.

Figure 8:
Simple Configuration



TQFN55-40 PACKAGE OUTLINE AND DIMENSIONS



| SYMBOL | DIMENSION IN MILLIMETERS | | DIMENSION IN INCHES | |
|--------|--------------------------|-------|---------------------|-------|
| | MIN | MAX | MIN | MAX |
| A | 0.700 | 0.800 | 0.028 | 0.031 |
| A1 | 0.200 REF | | 0.008 REF | |
| A2 | 0.000 | 0.050 | 0.000 | 0.002 |
| b | 0.150 | 0.250 | 0.006 | 0.010 |
| D | 4.900 | 5.100 | 0.193 | 0.201 |
| E | 4.900 | 5.100 | 0.193 | 0.201 |
| D2 | 3.450 | 3.750 | 0.136 | 0.148 |
| E2 | 3.450 | 3.750 | 0.136 | 0.148 |
| e | 0.400 BSC | | 0.016 BSC | |
| L | 0.300 | 0.500 | 0.012 | 0.020 |
| R | 0.300 | | 0.012 | |

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